TEXAS INSTRUMENTS
TLC555
ZHCSK03J – AUGUST 1983 – REVISED NOVEMBER 2023

TLC555 LinCMOS™ 技术计时器

1 特性

- 极低功耗：
  - V_{DD} = 5V 时为 1mW（典型值）
- 能够在非稳态模式下正常工作
- 支持轨到轨摆动的 CMOS 输出
- 高输出电流能力
  - 灌电流：100mA（典型值）
  - 拉电流：10mA（典型值）
- 输出与 CMOS、TTL 和 MOS 完全兼容
- 低电源电流在输出转换期间降低了尖峰
- 2V 至 15V 单电源运行
- 在功能上可与 NE555 互换；具有相同的引脚
- ESD 保护超出 ANSI/ESDA/JEDEC JS-001 规定的 1000V
- 可用于 Q 级温度汽车
  - 高可靠性汽车应用
  - 配置控制和打印支持
  - 通过汽车标准鉴定

2 应用

- 精确计时
- 脉冲发生
- 顺序计时
- 延时时间生成
- 脉宽调制
- 脉冲位置调制
- 线性斜坡发生器

3 说明

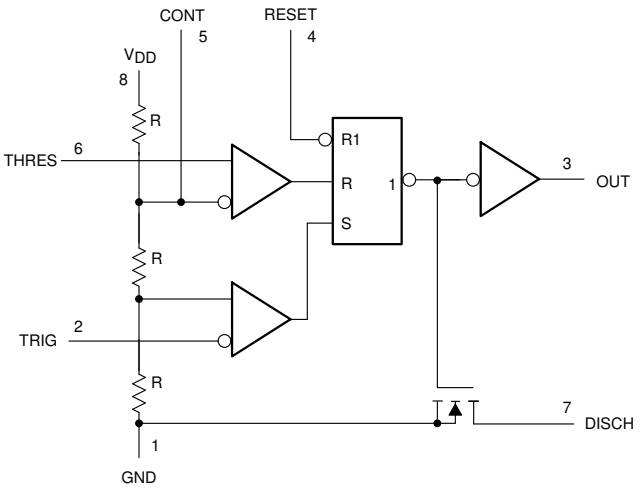
TLC555 是一款采用 TI LinCMOS™ 技术制造的单片定时电路。该计时器与 CMOS、TTL 和 MOS 逻辑器件完全兼容，可在最高 2MHz 的频率下运行。由于输入阻抗较高，此器件可支持比 NE555 或 LM555 所支持的计时电容器更小的计时电容器。因此，可实现更加准确的延时时间和振荡。在整个电源电压范围内可保持较低功耗。

与 NE555 类似，TLC555 有一个约等于电源电压三分之一的触发电平以及一个约等于电源电压三分之二的阈值电平。可使用控制电压端子 (CONT) 来改变这些电平。当触发输入 (TRIG) 下降至低于触发电平的时候，触发器被设定并且输出变为高电平。如果 TRIG 高于触发电平并且阈值输入 (THRES) 在阈值电平之上的话，触发器被复位并且输出为低电平。复位输入 (RESET) 的优先级高于所有其它输入并且可被用来启动一个新的定时周期。如果 RESET 为低电平，触发器被复位并且输出为低电平。只要当输出为低电平，在放电端子 (DISCH) 和接地 (GND) 之间提供一个低阻抗路径。所有未用输入端必须接入合适的逻辑电平以免发生误触发。

封装信息

器件型号	封装(1)	封装尺寸(2)
TLC555C	SOIC (8)	4.9mm × 6.0mm
	PDIP (8)	9.81mm × 9.43mm
	SOP (8)	6.2mm × 7.8mm
	TSSOP (14)	5.0mm × 6.4mm
TLC555I	SOIC (8)	4.9mm × 6.0mm
	PDIP (8)	9.81mm × 9.43mm
TLC555M	LCCC (20)	8.89mm × 8.89mm
	CDIP (8)	9.6mm × 9.0mm
TLC555Q	SOIC (8)	4.9mm × 6.0mm

(1) 有关详细信息，请参阅 节 10。
(2) 封装尺寸（长 × 宽）为标称值，并包括引脚（如适用）。



简化版原理图

本资源的原文使用英文撰写。 为方便起见，TI 提供了译文；由于翻译过程中可能使用了自动化工具，TI 不保证译文的准确性。 为确认准确性，请务必访问 ti.com 参考最新的英文版本（控制文档）。

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4 Pin Configuration and Functions

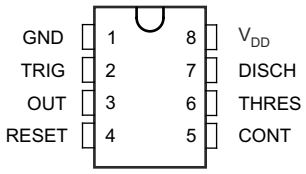


图 4-1. D, P, PS, and JG Packages, 8-Pin SOIC, PDIP, SOP, and CDIP (Top View)

表 4-1. Pin Functions: D, P, PS, and JG Packages

PIN		TYPE	DESCRIPTION
NAME	NO.		
CONT	5	Input	Controls comparator thresholds. Outputs 2/3 V_{DD} and allows bypass capacitor connection.
DISCH	7	Output	Open collector output to discharge timing capacitor.
GND	1	—	Ground.
NC	—	—	No internal connection.
OUT	3	Output	High current timer output signal.
RESET	4	Input	Active low reset input forces output and discharge low.
THRES	6	Input	End of timing input. THRES > CONT sets output low and discharge low.
TRIG	2	Input	Start of timing input. TRIG < 1/2 CONT sets output high and discharge open.
V_{DD}	8	—	Power-supply voltage.

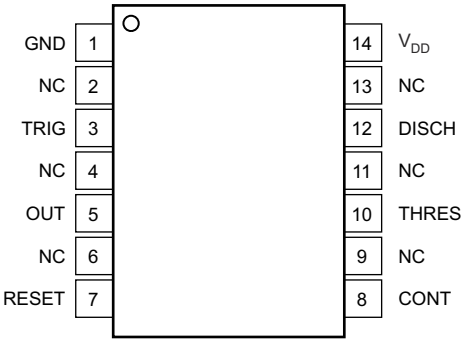


图 4-2. PW Package, 14-Pin TSSOP (Top View)

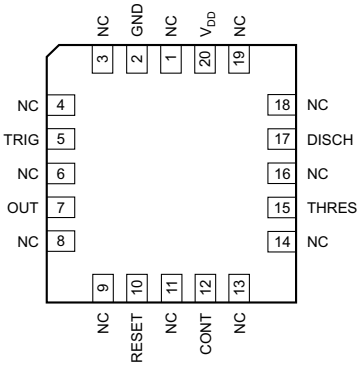


图 4-3. FK Package, 20-Pin LCCC (Top View)

表 4-2. Pin Functions: PW and FK

PIN			TYPE	DESCRIPTION
NAME	NO.			
	PW (TSSOP)	FK (LCCC)		
CONT	8	12	Input	Controls comparator thresholds. Outputs 2/3 V_{DD} and allows bypass capacitor connection.
DISCH	12	17	Output	Open-collector output to discharge timing capacitor.
GND	1	2	—	Ground.
NC	2, 4, 6, 9, 11, 13	1, 3, 4, 6, 8, 9, 11, 13, 14, 16, 18, 19	—	No internal connection.
OUT	5	7	Output	High current timer output signal.
RESET	7	10	Input	Active low reset input forces output and discharge low.
THRES	10	15	Input	End of timing input. THRES > CONT sets output low and discharge low.
TRIG	3	5	Input	Start of timing input. TRIG < 1/2 CONT sets output high and discharge open.

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表 4-2. Pin Functions: PW and FK（续）

PIN			TYPE	DESCRIPTION
NAME	NO.			
	PW (TSSOP)	FK (LCCC)		
V_{DD}	14	20	—	Power-supply voltage.

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5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
	Voltage	Supply, V_{DD} (2)	– 0.3	18	V
		Input, any input	– 0.3	V_{DD}	
		Discharge	– 0.3	18	
	Current	Sink, discharge or output		150	mA
		Source, output, I_O		15	
T_A	Operating temperature	C-suffix	0	70	°C
		I-suffix	– 40	85	
		Q-suffix	– 40	125	
		M-suffix	– 55	125	
	Case temperature, for 60 seconds	FK package	– 65	150	°C
T_{stg}	Storage temperature		– 65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2) All voltage values are with respect to network GND.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge(3)	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001(1)	±1000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002(2)	±1000	
		Machine model (MM)	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
(3) See 节 7.2.5 for application guidance on protecting the device against ESD.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{DD}	Supply voltage	TLC555C	2	15	V
		TLC555I	3	15	
		TLC555M	5	15	
		TLC555Q	5	15	
T_A	Operating free-air temperature	TLC555C	0	70	°C
		TLC555I	– 40	85	
		TLC555M	– 55	125	
		TLC555Q	– 40	125	

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5.4 Thermal Information

THERMAL METRIC[1]		TLC555						UNIT
		D (SOIC)	FK (LCCC)	JG (CDIP)	P (PDIP)	PS (SOP)	PW (TSSOP)	
		8 PINS	20 PINS	8 PINS	8 PINS	8 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	138.9	N/A	120	93.1	120	135	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	78.8	37	81	82.5	72	61	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	87.9	36	110	69.6	69	77	°C/W
ψ_{JT}	Junction-to-top characterization parameter	23.2	N/A	45	52.0	32	12	°C/W
ψ_{JB}	Junction-to-board characterization parameter	86.9	N/A	103	69.2	68	77	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	4.3	31	N/A	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

5.5 Electrical Characteristics: V_{DD} = 2 V for TLC555C, V_{DD} = 3 V for TLC555I

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS[1]		MIN	TYP	MAX	UNIT
V_{IT}	Threshold voltage	25°C	TLC555C	0.95	1.33	1.65	V
			TLC555I	1.6		2.4	
		Full range	TLC555C	0.85		1.75	
			TLC555I	1.5		2.5	
I_{IT}	Threshold current	25°C	TLC555C		10		pA
			TLC555I		10		
		Max	TLC555C		75		
			TLC555I		150		
$V_{I(TRIG)}$	Trigger voltage	25°C	TLC555C	0.4	0.67	0.95	V
			TLC555I	0.71	1	1.29	
		Full range	TLC555C	0.3		1.05	
			TLC555I	0.61		1.39	
$I_{I(TRIG)}$	Trigger current	25°C	TLC555C		10		pA
			TLC555I		10		
		Max	TLC555C		75		
			TLC555I		150		
$V_{I(RESET)}$	Reset voltage	25°C	TLC555C	0.4	1.1	1.5	V
			TLC555I	0.4	1.1	1.5	
		Full range	TLC555C	0.3		2	
			TLC555I	0.3		1.8	
	Control voltage (open-circuit) as a percentage of supply voltage	Max	TLC555C		66.7%		
			TLC555I		66.7%		
	Discharge switch on-stage voltage	I_{OL} = 1 mA, 25°C	TLC555C		0.03	0.2	V
			TLC555I		0.03	0.2	
		I_{OL} = 1 mA, Full range	TLC555C			0.25	
			TLC555I			0.375	
	Discharge switch off-stage current	25°C	TLC555C		0.1		nA
			TLC555I		0.1		
		Max	TLC555C		0.5		
			TLC555I		120		

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5.5 Electrical Characteristics: V_{DD} = 2 V for TLC555C, V_{DD} = 3 V for TLC555I（续）

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS(1)		MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	I_{OH} = –300 μA, 25°C	TLC555C	1.5	1.9		V
			TLC555I	2.5	2.85		
		I_{OH} = –300 μA, Full range	TLC555C	1.5			
			TLC555I	2.5			
V_{OL}	Low-level output voltage	I_{OL} = 1 mA, 25°C	TLC555C		0.07	0.3	V
			TLC555I		0.07	0.3	
		I_{OL} = 1 mA, Full range	TLC555C			0.35	
			TLC555I			0.4	
I_{DD}	Supply current(2)	25°C	TLC555C			250	μA
			TLC555I			250	
		Full range	TLC555C			400	
			TLC555I			500	
C_{PD}	Power dissipation capacitance(3) (4)	25°C	TLC555C		80		pF
			TLC555I		90		

(1) Full range is 0°C to 70°C the for TLC555C, and –40°C to +85°C for the TLC555I. For conditions shown as MAX, use the appropriate value specified in the 节 5.3.
(2) These values apply for the expected operating configurations in which THRES is connected directly to DISCH or to TRIG.
(3) C_{PD} is used to determine the dynamic power consumption.
(4) $P_D = V_{DD}^2 f_o (C_{PD} + C_L)$ where f_o = output frequency, C_L = output load capacitance, V_{DD} = supply voltage.

5.6 Electrical Characteristics: V_{DD} = 5 V

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS(1)		MIN	TYP	MAX	UNIT
V_{IT}	Threshold voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	2.8	3.3	3.8	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	2.7		3.9	
I_{IT}	Threshold current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
$V_{I(TRIG)}$	Trigger voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	1.36	1.66	1.96	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	1.26		2.06	
$I_{I(TRIG)}$	Trigger current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
C_I	Trigger, threshold capacitance (each pin)	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		2.1		pF
$V_{I(RESET)}$	Reset voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	0.4	1.1	1.5	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	0.3		1.8	

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5.6 Electrical Characteristics: V_{DD} = 5 V（续）

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS[1]		MIN	TYP	MAX	UNIT
$I_{I(RESET)}$	Reset current	25°C, V_{RESET} = 0 V	TLC555C, TLC555I, TLC555M, TLC555Q		5.9		μA
		25°C, V_{RESET} = V_{DD}	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max, V_{RESET} = V_{DD}	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
	Control voltage (open circuit) as a percentage of supply voltage	Max	TLC555C, TLC555I, TLC555M, TLC555Q		66.7%		
	Discharge switch on-stage voltage	I_{OL} = 10 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.14	0.5	V
		I_{OL} = 10 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q			0.6	
	Discharge switch off-stage current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.1		nA
		Max	TLC555C		0.5		
			TLC555I		120		
			TLC555M, TLC555Q		120		
V_{OH}	High-level output voltage	I_{OH} = – 1 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q	4.1	4.8		V
		I_{OH} = – 1 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q	4.1			
V_{OL}	Low-level output voltage	I_{OL} = 8 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.21	0.4	V
		I_{OL} = 8 mA, Full range	TLC555C			0.5	
			TLC555I			0.5	
			TLC555M, TLC555Q			0.6	
V_{OL}	Low-level output voltage	I_{OL} = 5 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.13	0.3	V
		I_{OL} = 5 mA, Full range	TLC555C			0.4	
			TLC555I			0.4	
			TLC555M, TLC555Q			0.45	
		I_{OL} = 3.2 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.08	0.3	
		I_{OL} = 3.2 mA, Full range	TLC555C			0.35	
			TLC555I			0.35	
			TLC555M, TLC555Q			0.4	
I_{DD}	Supply current[2]	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		180	350	μA
		Full range	TLC555C			500	
			TLC555I			600	
			TLC555M, TLC555Q			700	
C_{PD}	Power dissipation capacitance[3] [4]	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		115		pF

(1) Full range is 0°C to 70°C the for TLC555C, – 40°C to 85°C for the TLC555I, – 40°C to 125°C for the TLC555Q, and – 55°C to 125°C for the TLC555M. For conditions shown as MAX, use the appropriate value specified in the *节 5.3* table.
(2) These values apply for the expected operating configurations in which THRES is connected directly to DISCH or to TRIG.
(3) C_{PD} is used to determine the dynamic power consumption.
(4) $P_D = V_{DD}^2 f_o (C_{PD} + C_L)$ where f_o = output frequency, C_L = output load capacitance, V_{DD} = supply voltage.

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5.7 Electrical Characteristics: V_{DD} = 15 V

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS[1]		MIN	TYP	MAX	UNIT
V_{IT}	Threshold voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	9.45	10	10.55	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	9.35		10.65	
I_{IT}	Threshold current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
$V_{I(TRIG)}$	Trigger voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	4.65	5	5.35	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	4.55		5.45	
$I_{I(TRIG)}$	Trigger current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
C_I	Trigger, threshold capacitance (each pin)	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		1.8		pF
$V_{I(RESET)}$	Reset voltage	25°C	TLC555C, TLC555I, TLC555M, TLC555Q	0.4	1.1	1.5	V
		Full range	TLC555C, TLC555I, TLC555M, TLC555Q	0.3		1.8	
$I_{I(RESET)}$	Reset current	25°C, V_{RESET} = 0 V	TLC555C, TLC555I, TLC555M, TLC555Q		17.8		µA
		25°C, V_{RESET} = V_{DD}	TLC555C, TLC555I, TLC555M, TLC555Q		10		pA
		Max, V_{RESET} = V_{DD}	TLC555C		75		
			TLC555I		150		
			TLC555M, TLC555Q		5000		
	Control voltage (open circuit) as a percentage of supply voltage	Max	TLC555C, TLC555I, TLC555M, TLC555Q		66.7%		
	Discharge switch on-stage voltage	I_{OL} = 100 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.77	1.7	V
		I_{OL} = 100 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q			1.8	
	Discharge switch off-stage current	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.1		nA
		Max	TLC555C		0.5		
			TLC555I		120		
			TLC555M, TLC555Q		120		
V_{OH}	High-level output voltage	I_{OH} = – 10 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q	12.5	14.2		V
		I_{OH} = – 10 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q	12.5			
		I_{OH} = – 5 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q	13.5	14.6		
		I_{OH} = – 5 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q	13.5			
		I_{OH} = – 1 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q	14.2	14.9		
		I_{OH} = – 1 mA, Full range	TLC555C, TLC555I, TLC555M, TLC555Q	14.2			

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5.7 Electrical Characteristics: V_{DD} = 15 V （续）

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS(1)		MIN	TYP	MAX	UNIT
V_{OL}	Low-level output voltage	I_{OL} = 100 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		1.28	3.2	V
		I_{OL} = 100 mA, Full range	TLC555C			3.6	
			TLC555I			3.7	
			TLC555M, TLC555Q			3.8	
		I_{OL} = 50 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.63	1	
		I_{OL} = 50 mA, Full range	TLC555C			1.3	
			TLC555I			1.4	
			TLC555M, TLC555Q			1.5	
		I_{OL} = 10 mA, 25°C	TLC555C, TLC555I, TLC555M, TLC555Q		0.12	0.3	
		I_{OL} = 10 mA, Full range	TLC555C			0.4	
			TLC555I			0.4	
			TLC555M, TLC555Q			0.45	
I_{DD}	Supply current(2)	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		360	600	µA
		Full range	TLC555C			800	
			TLC555I			900	
			TLC555M, TLC555Q			1000	
C_{PD}	Power dissipation capacitance(3) (4)	25°C	TLC555C, TLC555I, TLC555M, TLC555Q		140		pF

(1) Full range is 0°C to 70°C for TLC555C, – 40°C to 85°C for TLC555I, – 40°C to 125°C for the TLC555Q, and – 55°C to 125°C for TLC555M. For conditions shown as MAX, use the appropriate value specified in the 节 5.3 table.
(2) These values apply for the expected operating configurations in which THRES is connected directly to DISCH or TRIG.
(3) C_{PD} is used to determine the dynamic power consumption.
(4) $P_D = V_{DD}^2 f_o (C_{PD} + C_L)$ where f_o = output frequency, C_L = output load capacitance, V_{DD} = supply voltage.

5.8 Timing Characteristics

V_{DD} = 5 V, T_A = 25°C (unless otherwise noted). Characteristic values are specified by design, characterization, or both.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Supply voltage sensitivity of timing interval	V_{DD} = 5 V to 15 V, C_T = 0.1 µF $R_A = R_B$ = 1 kΩ to 100 kΩ (1)		0.1	0.5	%/V
t_r	Output pulse rise time	R_L = 10 MΩ, C_L = 10 pF		20	75	ns
t_f	Output pulse fall time	R_L = 10 MΩ, C_L = 10 pF		15	60	ns
f_{max}	Maximum frequency in a-stable mode	R_A = 470 Ω, C_T = 200 pF R_B = 200 Ω (1)	1.2	2.1		MHz

(1) R_A, R_B, and C_T are as defined in 图 6-5.

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5.9 Typical Characteristics

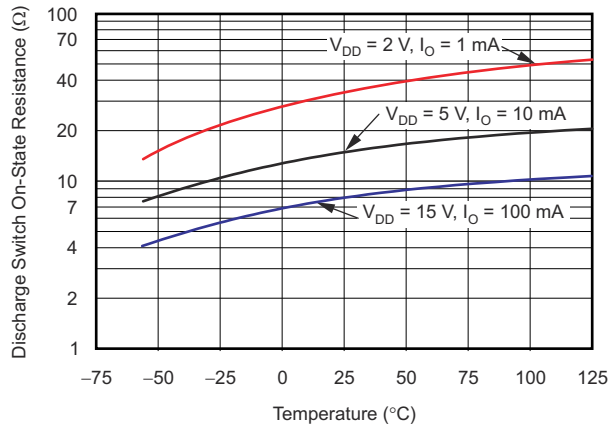
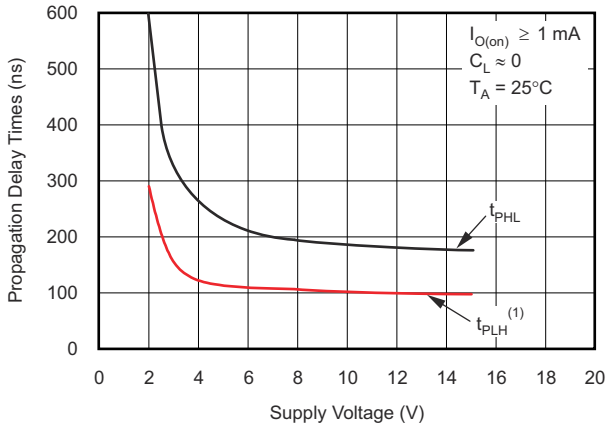


图 5-1. Discharge Switch On-State Resistance vs Free-Air Temperature



(1) The effects of the load resistance on these values must be taken into account separately.

图 5-2. Propagation Delay Times to Discharge Output From Trigger and Threshold Shorted Together vs Supply Voltage

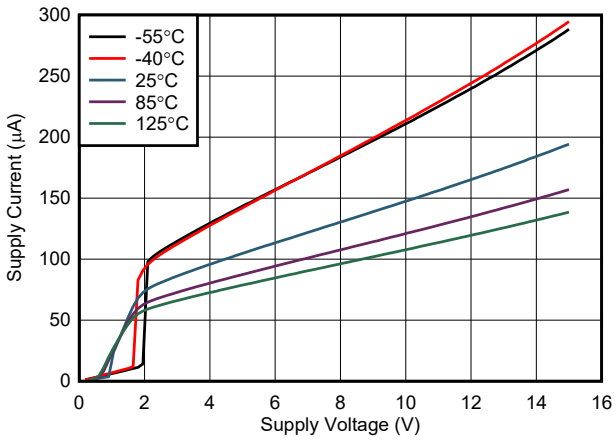


图 5-3. Supply Current vs Supply Voltage, Unit 1

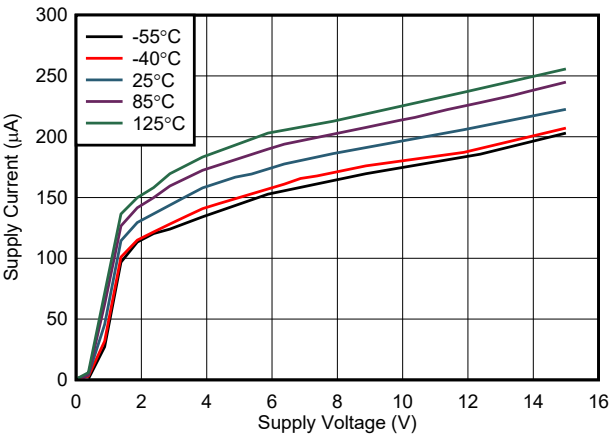


图 5-4. Supply Current vs Supply Voltage, Unit 2

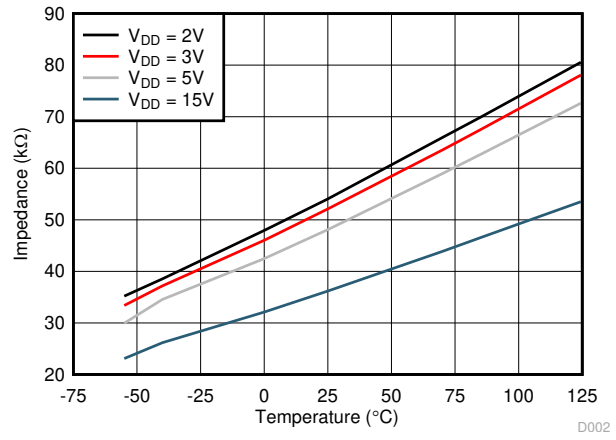


图 5-5. Control Impedance vs Temperature

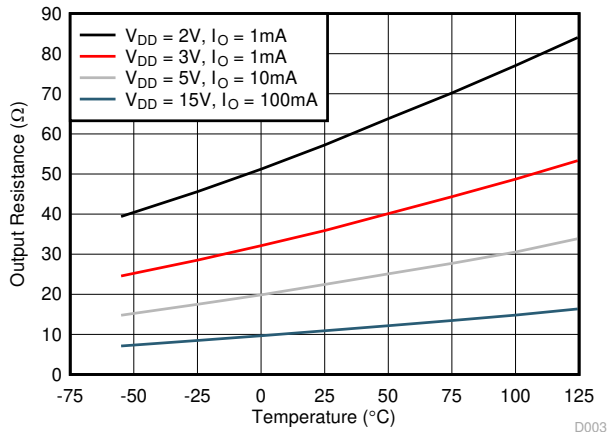


图 5-6. Output Low Resistance vs Temperature

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5.9 Typical Characteristics (continued)

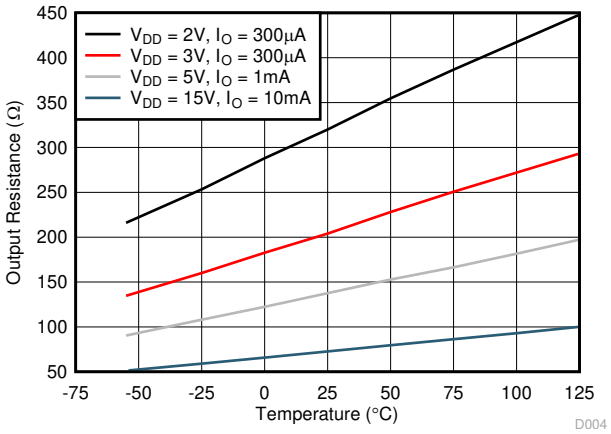
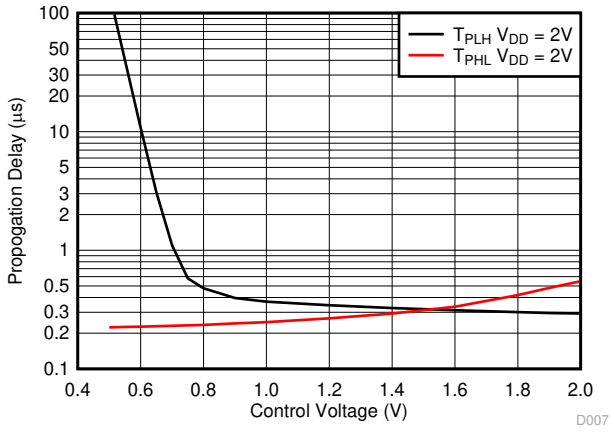
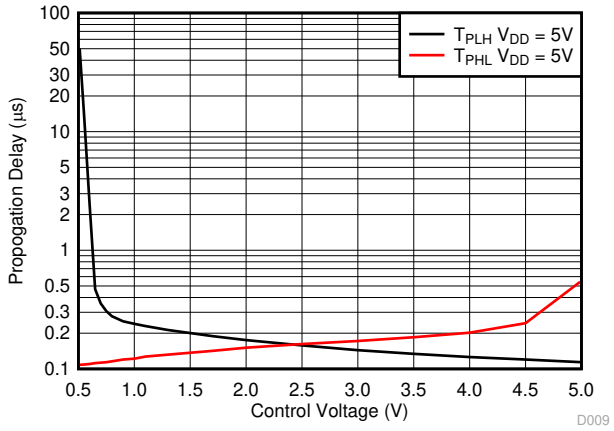


图 5-7. Output High Resistance vs Temperature



V_{DD} = 2 V

图 5-8. Propagation Delay vs Control Voltage



V_{DD} = 5 V

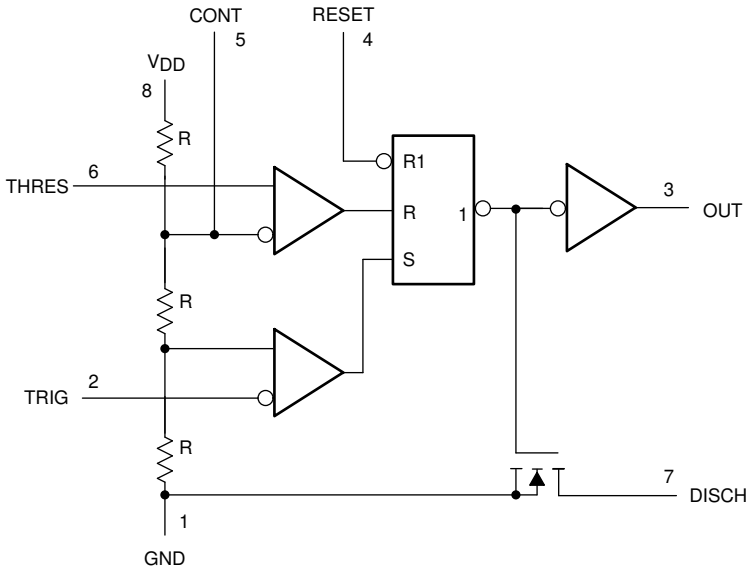
图 5-9. Propagation Delay vs Control Voltage

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6 Detailed Description

6.1 Overview

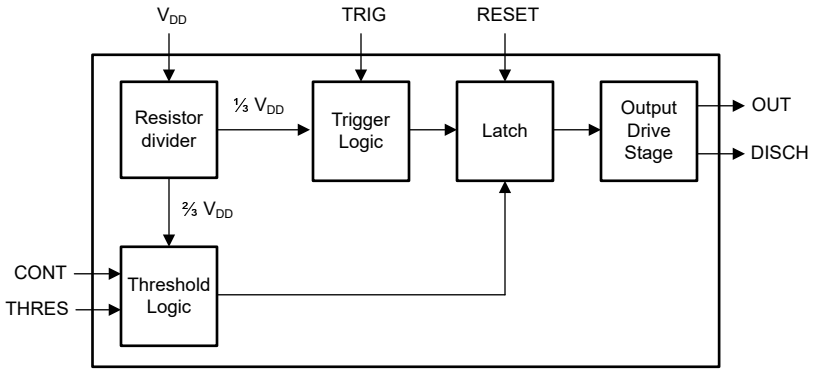
The TLC555 is a precision timing device used for general-purpose timing applications up to 2.1 MHz. All inputs are level sensitive, not edge-triggered inputs.



Pin numbers are for all packages except PW and FK. RESET overrides TRIG, which overrides THRES (when CONT pin is 2/3 V_{DD}). The resistance of R resistors vary with V_{DD} and temperature. The resistors match each other very well across V_{DD} and temperature for a temperature-stable control-voltage ratio.

图 6-1. Simplified Schematic

6.2 Functional Block Diagram



6.3 Feature Description

6.3.1 Monostable Operation

For monostable operation, 图 6-2 shows how any of these timers can be connected. If the output is low, application of a negative-going pulse to the trigger (TRIG) sets the internal latch; the output goes high, and discharge pin (DISCH) becomes open drain. Capacitor C then is charged through R_A until the voltage across the capacitor reaches the threshold voltage of the threshold (THRES) input. If TRIG has returned to a high level, the output of the threshold comparator resets the internal latch, the output goes low, the discharge pin goes low, which quickly discharges capacitor C.

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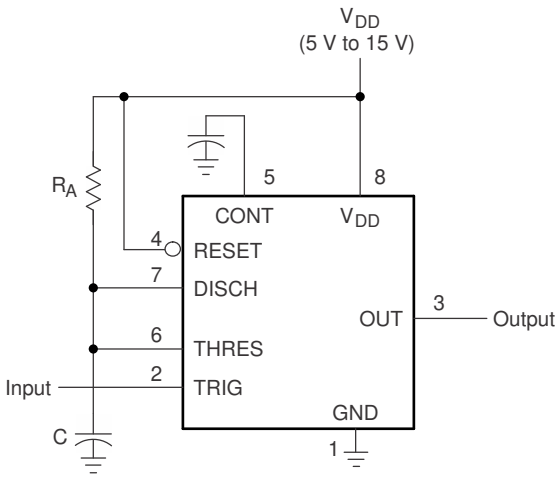


图 6-2. Circuit for Monostable Operation

Monostable operation is initiated when TRIG voltage is less than the trigger threshold. If initiated, the sequence ends only if TRIG is high for at least 1 µs before the end of the timing interval. When the trigger is grounded, the comparator storage time can be as long as 1 µs, which limits the minimum monostable pulse duration to 1 µs. The output pulse duration is approximately $t_w = 1.1 \times R_A C$. 图 6-4 is a plot of the time constant for various values of R_A and C. The threshold levels and charge rates both are directly proportional to the supply voltage, V_{DD}. The timing interval is, therefore, independent of the supply voltage, so long as the supply voltage is constant during the time interval.

Applying a negative-going trigger pulse simultaneously to RESET and TRIG during the timing interval discharges capacitor C and reinitiates the cycle, commencing on the positive edge of the reset pulse. The output is held low as long as the reset pulse is low. To prevent false triggering, when RESET is not asserted low, RESET must be connected to V_{DD}. If the RESET function is required and the pin is driven by external logic or a microcontroller, use a pullup resistor to V_{DD} (such as 10 kΩ) to prevent the RESET pin from floating. If the RESET function is not required, short the RESET pin directly to the V_{DD} pin.

In monostable applications, set the trip point of the trigger input by a voltage applied to CONT. An input voltage between 10% and 80% of the supply voltage, from a resistor divider with at least 500-µA bias, provides good results.

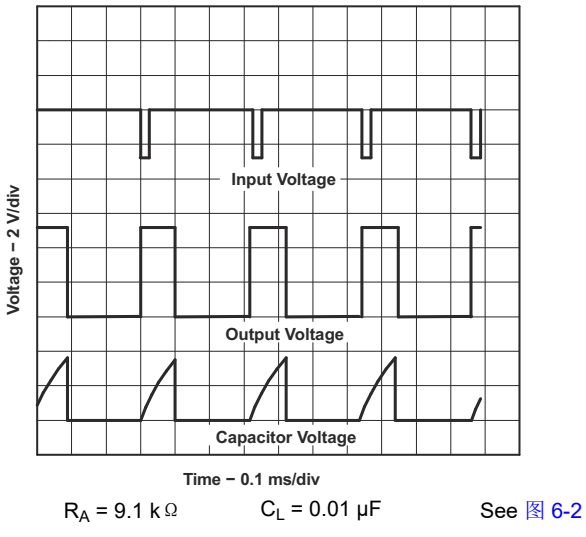


图 6-3. Typical Monostable Waveforms

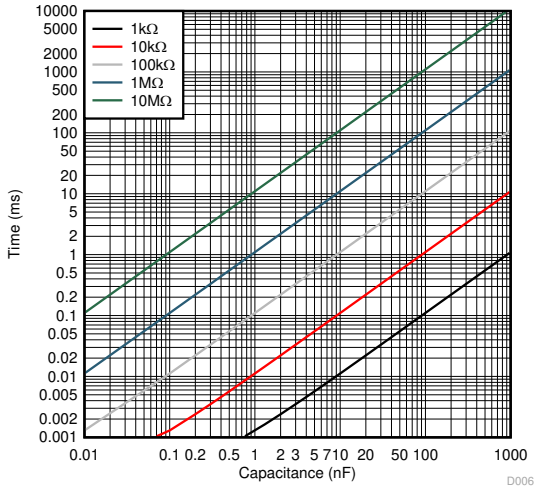


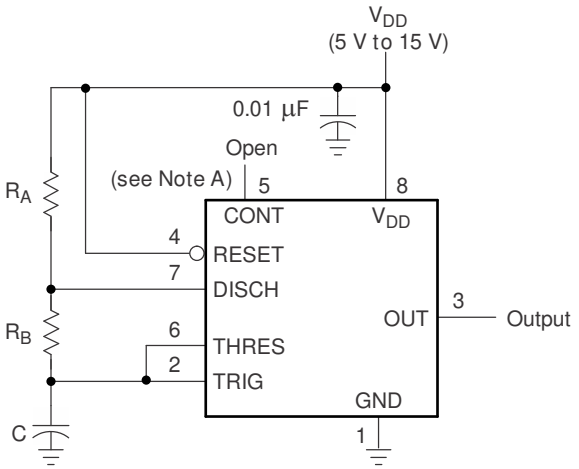
图 6-4. Output Pulse Duration vs Capacitance

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6.3.2 Astable Operation

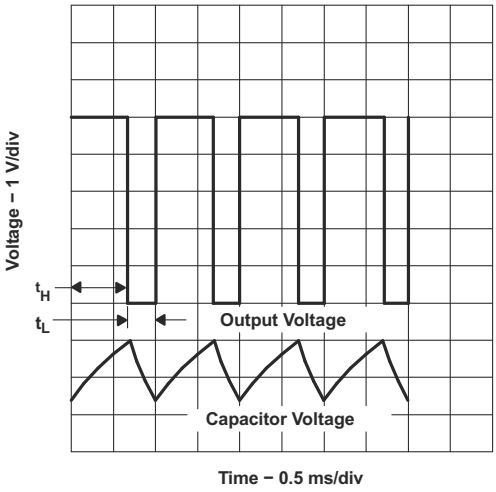
As shown in 图 6-5, adding a second resistor, R_B, to the circuit of 图 6-2 and connecting the trigger input to the threshold input causes the timer to self-trigger and run as a multivibrator. The capacitor C charges through R_A and R_B and then discharges through R_B only. Therefore, the duty cycle is controlled by the values of R_A and R_B.

This astable connection results in capacitor C charging and discharging between the threshold-voltage level ($\approx 0.67 \times V_{CC}$) and the trigger-voltage level ($\approx 0.33 \times V_{CC}$). As in the monostable circuit, charge and discharge times (and, therefore, the frequency and duty cycle) are independent of the supply voltage.



Decouple CONT voltage to ground with a capacitor to improve operation. Reevaluate for individual applications.

图 6-5. Circuit for Astable Operation



R_A = 5 kΩ R_B = 3 kΩ C = 0.15 µF

See 图 6-5

图 6-6. Typical Astable Waveforms

图 6-6 shows typical waveforms generated during astable operation. The output high-level duration t_H and low-level duration t_L for frequencies below 100 kHz can be calculated as follows:

$$t_H = 0.693(R_A + R_B)C \quad (1)$$

$$t_L = 0.693(R_B)C \quad (2)$$

Other useful relationships are shown below:

$$\text{period} = t_H + t_L = 0.693(R_A + 2R_B)C \quad (3)$$

$$\text{frequency} \approx \frac{1.44}{(R_A + 2R_B)C} \quad (4)$$

$$\text{Output driver duty cycle} = \frac{t_L}{t_H + t_L} = \frac{R_B}{R_A + 2R_B} \quad (5)$$

$$\text{Output waveform duty cycle} = \frac{t_H}{t_H + t_L} = 1 - \frac{R_B}{R_A + 2R_B} \quad (6)$$

$$\text{Low-to-high ratio} = \frac{t_L}{t_H} = \frac{R_B}{R_A + R_B} \quad (7)$$

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方程式 1 to 方程式 7 do not account for any propagation delay times from the TRIG and THRES inputs to DISCH output. These delay times add directly to the period and overcharge the capacitor, which creates differences between calculated and actual values that increase with frequency. In addition, the internal on-state resistance r_{on} during discharge adds to R_B to provide another source of timing error in the calculation when R_B is very low. The following equations provide better agreement with measured values. The formulas in 方程式 8 represent the actual low and high times when used at higher frequencies (beyond 100 kHz) because propagation delay and discharge on resistance is added to the formulas. The value of C_T includes both the nominal or deliberate timing capacitance, as well as parasitic capacitance on the PCB. Decoupling capacitance on CONT also affects the duty cycle, with an error contribution that depends on the capacitor leakage resistance. For additional discussion, see the *Design low-duty-cycle timer circuits* article.

$$t_{c(H)} = C_T\,(R_A + R_B)\,\ln\left[3 - \exp\left(\frac{-t_{PLH}}{C_T(R_B + r_{on})}\right)\right] + t_{PHL}$$
$$t_{c(L)} = C_T\,(R_B + r_{on})\,\ln\left[3 - \exp\left(\frac{-t_{PHL}}{C_T(R_A + R_B)}\right)\right] + t_{PLH} \quad (8)$$

These equations and those given earlier are similar in that a time constant is multiplied by the logarithm of a number or function. The limit values of the logarithmic terms must be between ln(2) at low frequencies, and ln(3) at extremely high frequencies. For a duty cycle close to 50%, an appropriate constant for the logarithmic terms can be substituted with good results. Output waveform duty cycles less than 50% require that $t_{c(H)} / t_{c(L)} < 1$ and possibly that $R_A \leqslant r_{on}$. These conditions can be difficult to obtain. 图 6-8 shows the nominal free-running frequency associated with various combinations of C_T and $R_A + 2 \times R_B$.

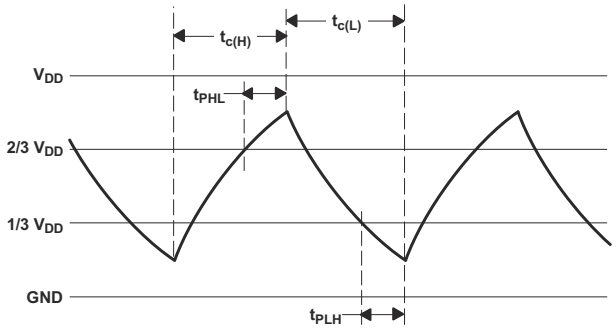


图 6-7. Trigger and Threshold Voltage Waveform

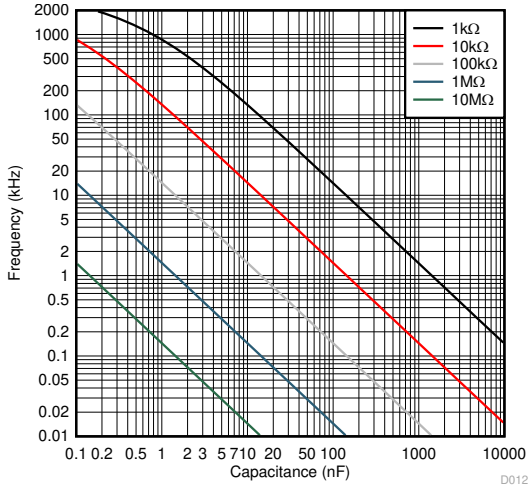
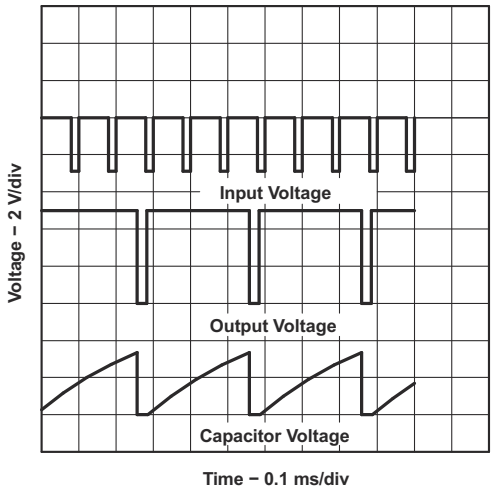


图 6-8. Nominal Free-Running Frequency vs Timing Capacitance
Resistance = $R_A + 2 \times R_B$

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6.3.3 Frequency Divider

By adjusting the length of the timing cycle, the basic circuit of 图 6-2 can be made to operate as a frequency divider. 图 6-9 shows a divide-by-three circuit that makes use of the fact that retriggering cannot occur during the timing cycle.



V_{CC} = 5 V R_A = 1250 Ω C = 0.02 µF

See 图 6-2

图 6-9. Divide-by-Three Circuit Waveforms

6.4 Device Functional Modes

表 6-1 shows the device truth table. For a valid reset voltage condition, use an external pullup resistor to V_{DD} (if using the RESET functionality), or short the RESET pin directly to V_{DD} (if the RESET functionality is not used).

表 6-1. Function Table

RESET VOLTAGE(1)	TRIGGER VOLTAGE(1)	THRESHOLD VOLTAGE(1)	OUTPUT	DISCHARGE SWITCH
< MIN	Irrelevant	Irrelevant	L	On
> MAX	< MIN	Irrelevant(2)	H	Off
> MAX	> MAX	> MAX	L	On
> MAX	> MAX	< MIN	As previously established	

(1) For conditions shown as MIN or MAX, use the appropriate value specified under 节 5.6.
(2) CONT pin open or 2/3 V_{DD}.

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7 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客 户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

7.1 Application Information

The TLC555 timer device uses resistor and capacitor charging delay to provide a programmable time delay or operating frequency. *节 7.2* presents a simplified discussion of the design process. Reset mode forces output and discharge low and provides a small reduction in supply current.

7.2 Typical Applications

7.2.1 Missing-Pulse Detector

The circuit shown in 图 7-1 can be used to detect a missing pulse or abnormally long spacing between consecutive pulses in a train of pulses. The timing interval of the monostable circuit is re-triggered continuously by the input pulse train as long as the pulse spacing is less than the timing interval. A longer pulse spacing, missing pulse, or terminated pulse train permits the timing interval to be completed, thereby generating an output pulse as shown in 图 7-2.

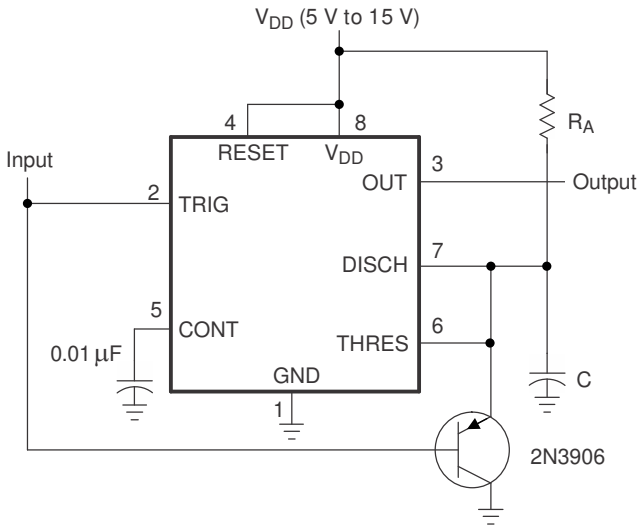


图 7-1. Circuit for Missing-Pulse Detector

7.2.1.1 Design Requirements

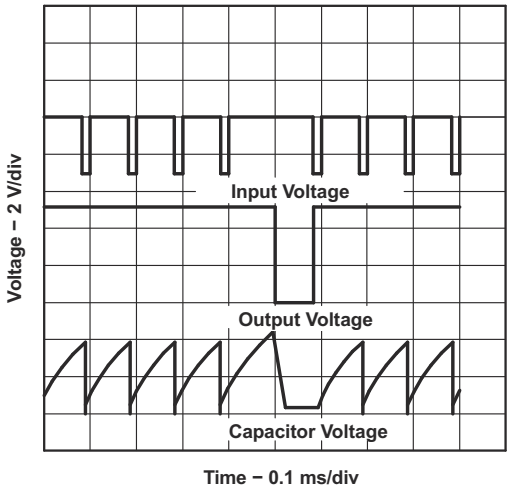
Input fault (missing pulses) must be input high. An input stuck low cannot be detected because the timing capacitor (C) remains discharged.

7.2.1.2 Detailed Design Procedure

Choose R_A and C so that $R_A \times C >$ [maximum normal input high time].

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7.2.1.3 Application Curve



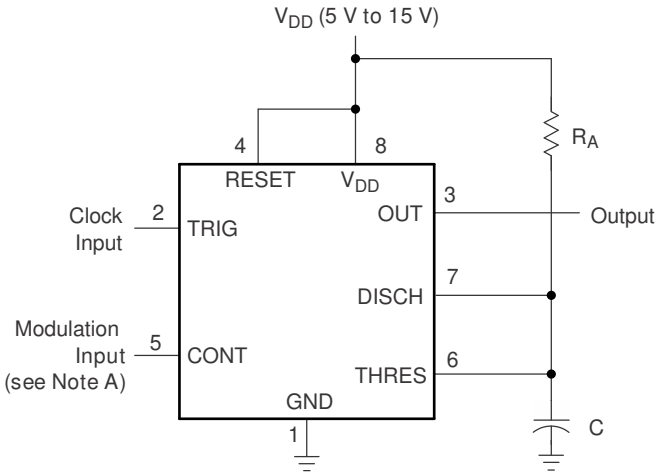
V_{DD} = 5 V R_A = 1 kΩ C = 0.1 µF

See 图 7-1

图 7-2. Timing Waveforms for Missing-Pulse Detector

7.2.2 Pulse-Width Modulation

To modify timer operation, apply an external voltage (or current) to CONT to modulate the internal threshold and trigger voltages. 图 7-3 shows a circuit for pulse-width modulation. A continuous input pulse train triggers the monostable circuit, and a control signal modulates the threshold voltage. 图 7-4 shows the resulting duty cycle versus control voltage transfer function. Attempting to run under 10% duty cycle can result in inconsistent output pulses. Attempting to run close to 100% duty cycle results in frequency division by 2, then 3, then 4.



A. The modulating signal can be direct or capacitively coupled to CONT. For direct coupling, consider the effects of modulation source voltage and impedance on the bias of the timer.

图 7-3. Circuit for Pulse-Width Modulation

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7.2.2.1 Design Requirements

The clock input must have V_{OL} and V_{OH} levels that are less than and greater than 1/3 V_{DD}, respectively. Clock input V_{OL} time must be less than minimum output high time; therefore, a high (positive) duty cycle clock is recommended. Minimum recommended modulation voltage is 1 V. Lower CONT voltage can greatly increase threshold comparator propagation delay and storage time. The application must be tolerant of a nonlinear transfer function; the relationship between modulation input and pulse width is not linear because the capacitor charge is RC-based with an negative exponential curve.

7.2.2.2 Detailed Design Procedure

Choose R_A and C so that R_A × C is same or less than clock input period. 图 7-4 shows the non linear relationship between control voltage and output duty cycle. Duty cycle is function of control voltage and clock period relative to RC time constant.

7.2.2.3 Application Curve

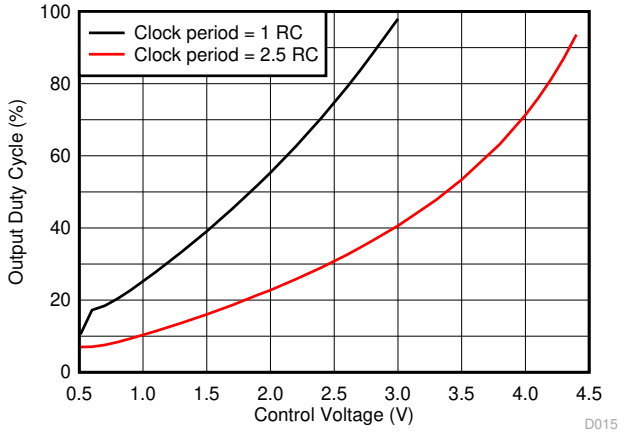
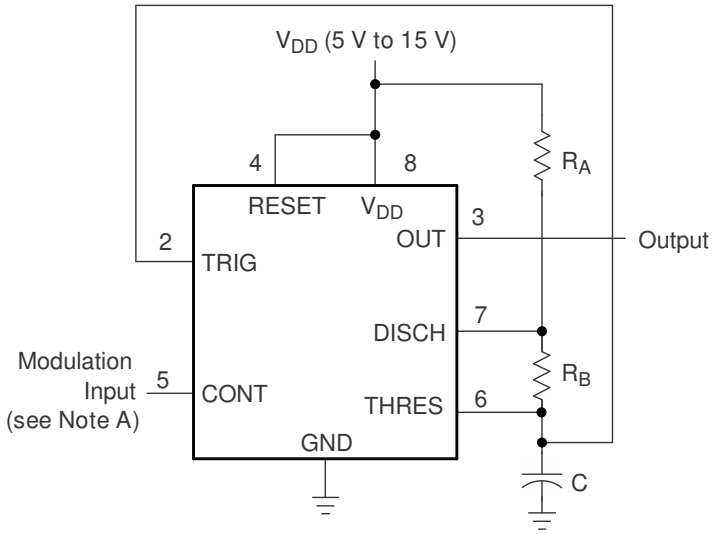


图 7-4. Pulse-Width-Modulation vs Control Voltage Clock Duty Cycle 98%, V_{DD} = 5 V

7.2.3 Pulse-Position Modulation

As shown in 图 7-5, any of these timers can be used as a pulse-position modulator. This application modulates the threshold voltage and thereby the time delay of a free-running oscillator. 图 7-6 and 图 7-7 shows the output frequency and duty cycle versus control voltage.

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A. The modulating signal can be direct or capacitively coupled to CONT. For direct coupling, consider the effects of modulation source voltage and impedance on the bias of the timer.

R_A = 3 kΩ R_B = 309 kΩ C = 1 nF

图 7-5. Circuit for Pulse-Position Modulation

7.2.3.1 Design Requirements

Both dc- and ac-coupled modulation input changes the upper and lower voltage thresholds for the timing capacitor. Both frequency and duty cycle vary with the modulation voltage. Control voltage less than 1 V can result in output glitches instead of a steady-output pulse stream

7.2.3.2 Detailed Design Procedure

The nominal output frequency and duty cycle for control voltage set to 2/3 of V_{DD} can be determined using formulas in 节 *6.3.2* section.

7.2.3.3 Application Curves

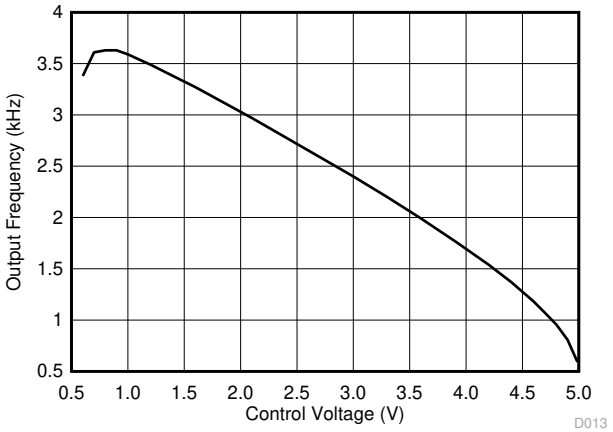


图 7-6. Pulse-Position-Modulation Frequency vs Control Voltage, V_{DD} = 5 V

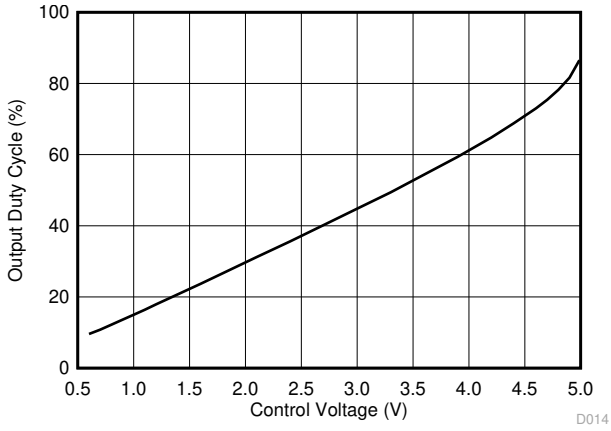
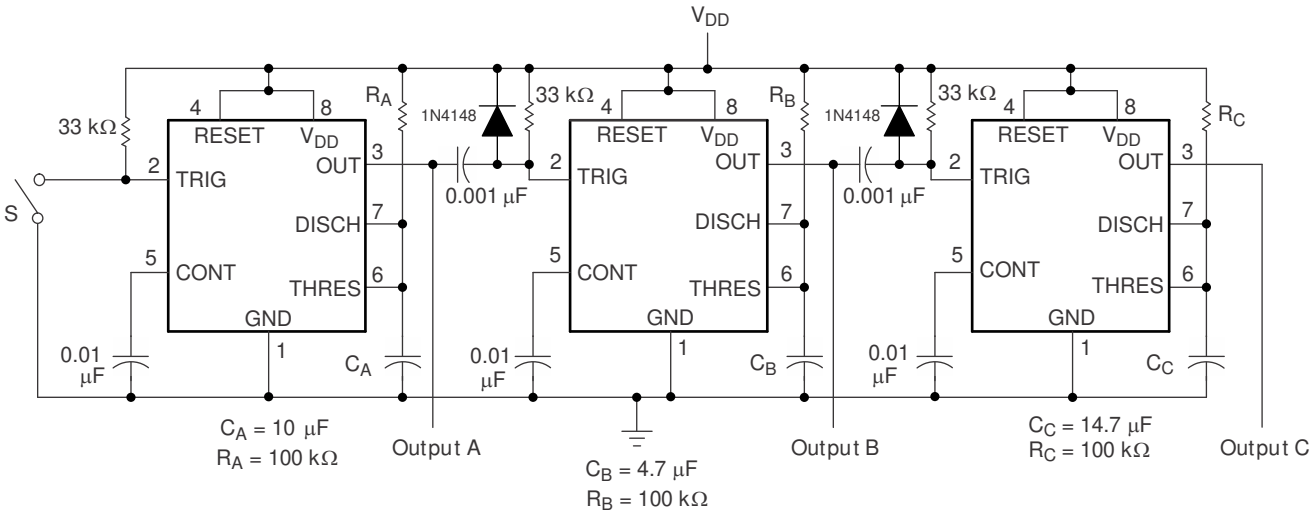


图 7-7. Pulse-Position-Modulation Duty Cycle vs Control Voltage, V_{DD} = 5 V

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7.2.4 Sequential Timer

Many applications, such as computers, require signals for initializing conditions during start-up. Other applications, such as test equipment, require activation of test signals in sequence. These timing circuits can be connected to provide such sequential control. The timers can be used in various combinations of astable or monostable circuit connections, with or without modulation, for extremely flexible waveform control. 图 7-8 shows a sequencer circuit with possible applications in many systems, and 图 7-9 shows the output waveforms.



S closes momentarily at t = 0.

图 7-8. Sequential Timer Circuit

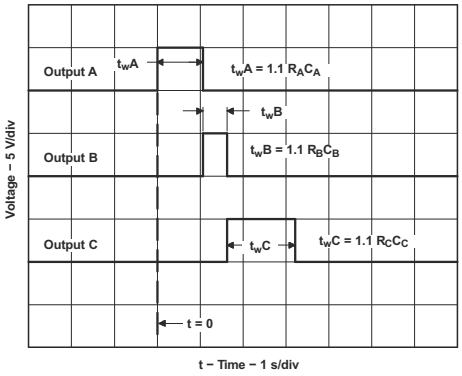
7.2.4.1 Design Requirements

The sequential-timer application chains together multiple monostable timers. The joining components are the 33-kΩ resistors and 0.001-µF capacitors. The output high-to-low edge passes a 10-µs start pulse to the next monostable. A diode is required to prevent overvoltage on the trigger input when on the previous output low-to-high edge.

7.2.4.2 Detailed Design Procedure

The timing resistors and capacitors can be chosen using this formula: $t_w = 1.1 \times R \times C$.

7.2.4.3 Application Curve



See 图 7-8

图 7-9. Sequential Timer Waveforms

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7.2.5 Designing for Improved ESD Performance

The TLC555 internal HBM and CDM protection allows for safe assembly in ESD-controlled environments. In applications that expose the pins of the TLC555 to ESD, additional protection is highly recommended. The following test board schematic has bypass capacitors, current-limiting resistors, and voltage-clamping TVS diodes to provide additional protection for commonly exposed pins (Reset, Trig, and Output) against ESD.

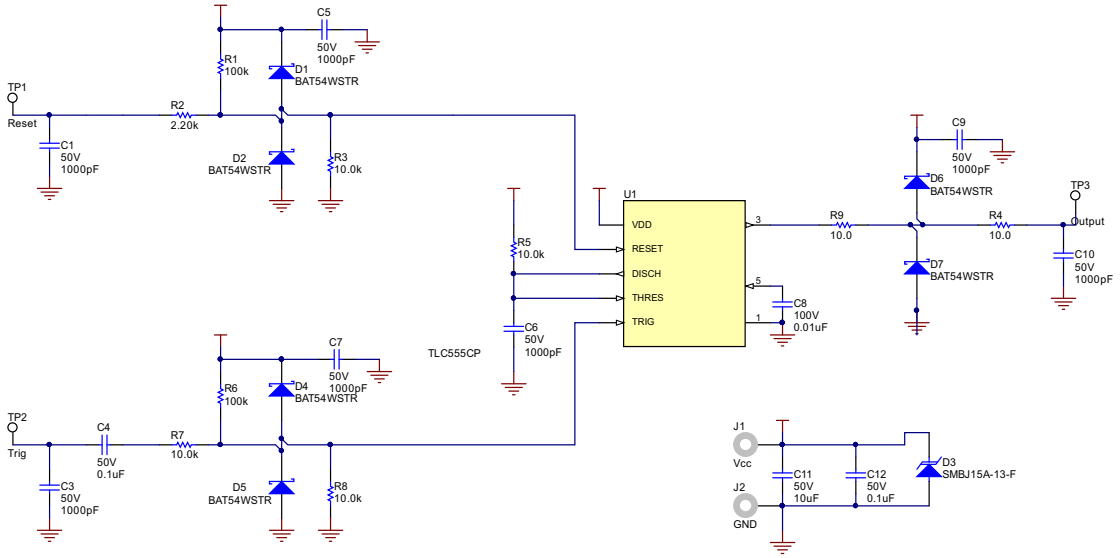


图 7-10. ESD Test Schematic

The following table gives the ESD protection levels recorded for different supply voltages and external components populated. Using only passive components to protect the TLC555 with a single 15-V supply is not recommended because the higher voltage allows for an unacceptable amount of current to flow through the device.

表 7-1. ESD Test Results

SUPPLY VOLTAGE	ONLY PASSIVE COMPONENTS POPULATED D1..D7 NOT POPULATED(1)	ALL COMPONENTS POPULATED (1)
5 V	8 kV	12 kV
15 V	Not recommended	12 kV

(1) Sample results. Results can vary with populated components, board layout, and samples used.

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7.3 Power Supply Recommendations

The TLC555 requires a voltage supply greater than or equal to 2 V, 3 V, or 5 V based the coldest ambient temperature supported and a supply voltage less than or equal to 15 V. Adequate power supply bypassing is necessary to protect associated circuitry and provide stable output pulses. Minimum recommended is 0.1-μF ceramic in parallel with 1-μF electrolytic. Place the bypass capacitors as close as possible to the TLC555 and minimize the trace length.

7.4 Layout

7.4.1 Layout Guidelines

Standard PCB rules apply to routing the TLC555. The 0.1-μF ceramic capacitor in parallel with a 1-μF electrolytic capacitor must be as close as possible to the TLC555. The capacitor used for the time delay must also be placed as close to the discharge pin. A ground plane on the bottom layer can be used to provide better noise immunity and signal integrity.

图 7-11 is the basic layout for various applications.

- C1—based on time delay calculations
- C2—0.01-μF bypass capacitor for control voltage pin
- C3—0.1-μF bypass ceramic capacitor
- C4—1-μF electrolytic bypass capacitor
- R1—based on time-delay calculations

7.4.2 Layout Example

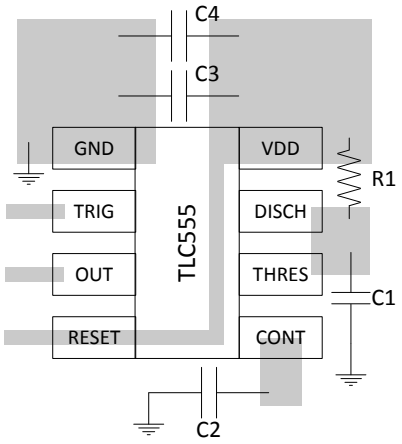


图 7-11. Layout Example

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8 Device and Documentation Support

8.1 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击*通知* 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

8.2 支持资源

TI E2E™ 中文支持论坛是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

8.5 术语表

TI 术语表　　本术语表列出并解释了术语、首字母缩略词和定义。

9 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision I (July 2019) to Revision J (November 2023) **Page**

- 将*特性* 中的 ESD 保护规格从 MIL-STD-883C 方法 3015.2 规定的 2000V 更改为 ANSI/ESDA/JEDEC JS-001 规定的 1000V 1
- 将*说明* 部分中的*器件信息* 表更改为*封装信息*，并将*封装尺寸（标称值）*更改为*封装尺寸* 1
- Added *ESD Ratings* table and HBM, CDM, and MM specifications 5
- Changed thermal resistance and characterization parameter values for SOIC and PDIP packages in *Thermal Information* table 6
- Changed reset current (I_{RESET}) test conditions to $V_{RESET} = V_{DD}$, in *Electrical Characteristics: V_{DD} = 5 V* and *Electrical Characteristics: V_{DD} = 15 V* 7
- Added new reset current (I_{RESET}) typical specification, for test condition V_{RESET} = 0 V, to *Electrical Characteristics: V_{DD} = 5 V* and *Electrical Characteristics: V_{DD} = 15 V* 7
- Changed supply current (I_{DD}) typical value from 170 µA to 180 µA in *Electrical Characteristics: V_{DD} = 5 V* . 7
- Changed title of *Operating Characteristics* section to *Timing Characteristics* and clarified that values are specified by design or characterization 10
- Deleted Initial error of timing interval specification in *Timing Characteristics* 10
- Added Figure 5-4, *Supply Current vs Supply Voltage, Unit 2* 11
- Changed Figure 5-3, *Supply Current vs Supply Voltage*, to add "Unit 1" to title, and deleted 0°C and 70°C curves 11
- Changed functional block diagram to simplified schematic and moved to *Overview* 13
- Updated *Functional Block Diagram* 13
- Added guidance for RESET pin pullup resistance and CONT pin voltage range to *Monostable Operation* ... 13
- Added clarity regarding nominal operating frequency and parasitic terms in *Astable Operation* 15
- Deleted link to deprecated TLC555 Design Calculator in *Astable Operation* 15

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- Deleted Figure 17, *Equivalent Schematic*, and added guidance concerning the RESET pin in *Device Functional Modes* 17

Changes from Revision H (August 2016) to Revision I (July 2019) **Page**

- Added MIN value for input voltage in *Absolute Maximum Ratings* 5
- Added discharge pin in *Absolute Maximum Ratings* 5
- Changed MIN supply voltage based on part number in *Recommended Operating Conditions* 5
- Added power dissipation capacitance TYP value in *Electrical Characteristics: V_{DD} = 2 V for TLC555C, V_{DD} = 3 V for TLC555I* 6
- Added trigger, threshold capacitance TYP value in *Electrical Characteristics: V_{DD} = 5 V* 7
- Changed V_{OH} test condition current to – 1 mA in *Electrical Characteristics: V_{DD} = 5 V* 7
- Added power dissipation capacitance TYP value in *Electrical Characteristics: V_{DD} = 5 V* 7
- Added trigger, threshold capacitance TYP value in *Electrical Characteristics: V_{DD} = 15 V* 9
- Added power dissipation capacitance TYP value in *Electrical Characteristics: V_{DD} = 15 V* 9
- Added *Operating Characteristics* to the *Specifications* section 10
- Added Supply Current vs Supply Voltage chart to the *Typical Characteristics* section 11
- Added Control Impedance vs Temperature chart to the *Typical Characteristics* section 11
- Added Output Low Resistance vs Temperature chart to the *Typical Characteristics* section 11
- Added Output High Resistance vs Temperature chart to the *Typical Characteristics* section 11
- Added Propagation Delay vs Control Voltage chart, V_{DD} = 2 V to the *Typical Characteristics* section 11
- Added Propagation Delay vs Control Voltage chart, V_{DD} = 5 V to the *Typical Characteristics* section 11
- Changed trigger high hold time to 1 µs in *Monostable Operation* 13
- Changed minimum monostable pulse width to 1 µs in *Monostable Operation* 13
- Changed Output Pulse Duration vs Capacitance chart scale down to 0.001 ms in *Monostable Operation* 13
- Added more astable frequency formulas to the *Astable Operation* section 15
- Changed scale on Free-Running Frequency vs Timing Capacitance chart up to 2 MHz in the *Astable Operation* section 15
- Added CONT pin table note to the Table 6-1, *Function Table* in the *Device Functional Modes* 17
- Changed the application curve chart in the *Pulse-Width Modulation* section 20
- Changed the application curve charts in the *Pulse-Position Modulation* section 21
- Added clamping diodes to Sequential Timer Circuit in the *Sequential Timer* section 22
- Added *Designing for Improved ESD Performance* section to the *Application Information* section 23

Changes from Revision G (November 2008) to Revision H (August 2016) **Page**

- 添加了*特性说明*部分、*器件功能模式*、*应用和实现*部分、*电源相关建议*部分、*布局*部分、*器件和文档支持*部分以及*机械、封装和可订购信息*部分 1
- Changed values in the *Thermal Information* table to align with JEDEC standards 6
- Deleted *Dissipation Ratings* table 6

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-89503012A	Active	Production	LCCC (FK) | 20	55 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-89503012A TLC555MFKB
5962-8950301PA	Active	Production	CDIP (JG) | 8	50 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8950301PA TLC555M
TLC555CDR	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TL555C
TLC555CDR.A	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TL555C
TLC555CP	Active	Production	PDIP (P) | 8	50 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC555CP
TLC555CP.A	Active	Production	PDIP (P) | 8	50 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC555CP
TLC555CPS	Active	Production	SO (PS) | 8	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPS.A	Active	Production	SO (PS) | 8	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPSR	Active	Production	SO (PS) | 8	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPSR.A	Active	Production	SO (PS) | 8	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPW	Active	Production	TSSOP (PW) | 14	90 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPW.A	Active	Production	TSSOP (PW) | 14	90 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPWR	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555CPWR.A	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P555
TLC555ID	Obsolete	Production	SOIC (D) | 8	-	-	Call TI	Call TI	-40 to 85	TL555I
TLC555IDR	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL555I
TLC555IDR.A	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL555I
TLC555IP	Active	Production	PDIP (P) | 8	50 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC555IP
TLC555IP.A	Active	Production	PDIP (P) | 8	50 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC555IP
TLC555MFKB	Active	Production	LCCC (FK) | 20	55 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-89503012A TLC555MFKB
TLC555MFKB.A	Active	Production	LCCC (FK) | 20	55 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-89503012A TLC555MFKB
TLC555MJG	Active	Production	CDIP (JG) | 8	50 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	TLC555MJG
TLC555MJG.A	Active	Production	CDIP (JG) | 8	50 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	TLC555MJG

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC555MJGB	Active	Production	CDIP (JG) | 8	50 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8950301PA TLC555M
TLC555MJGB.A	Active	Production	CDIP (JG) | 8	50 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	8950301PA TLC555M
TLC555QDR	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TL555Q
TLC555QDR.A	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TL555Q
TLC555QDRG4	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	TL555Q
TLC555QDRG4.A	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TL555Q

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF TLC555, TLC555M :

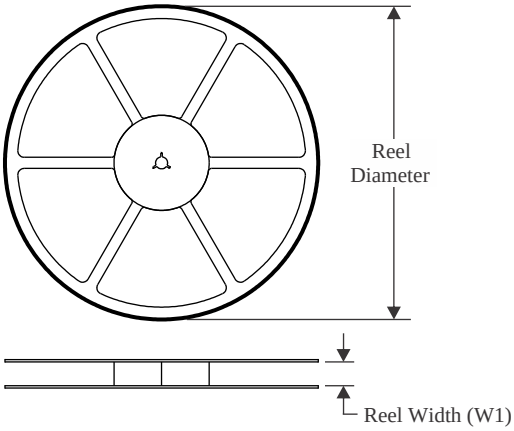
- Catalog : TLC555
- Automotive : TLC555-Q1, TLC555-Q1
- Military : TLC555M

NOTE: Qualified Version Definitions:

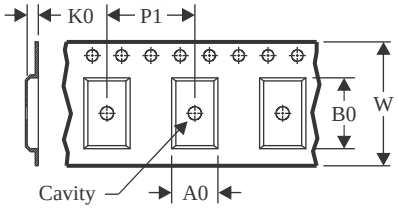
- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

REEL DIMENSIONS

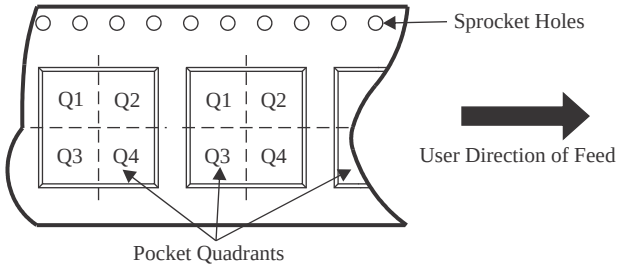


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

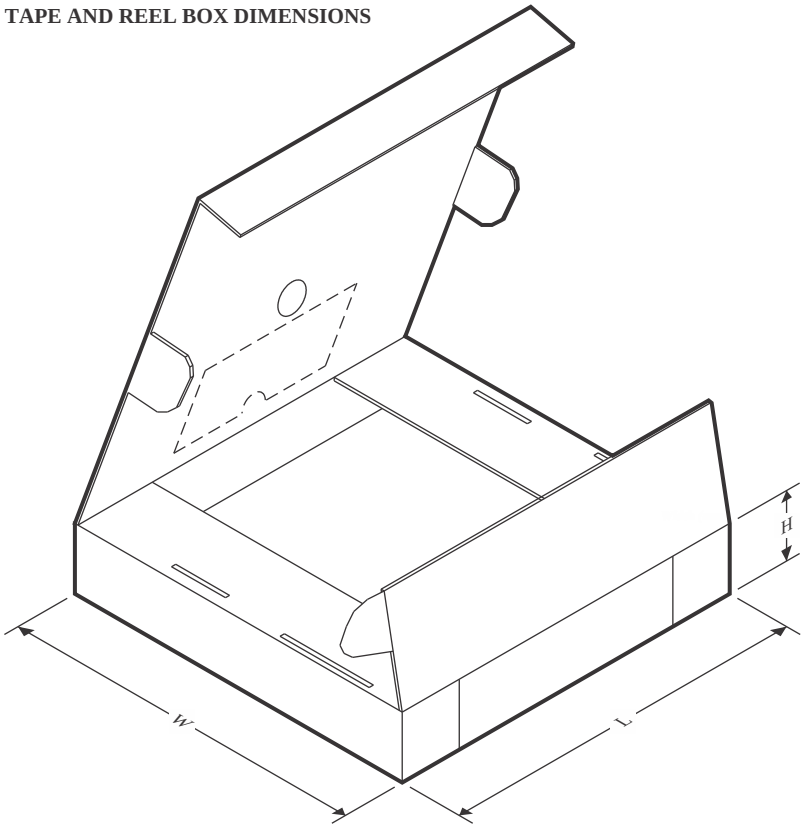
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC555CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC555CPSR	SO	PS	8	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
TLC555CPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC555IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC555QDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC555QDRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

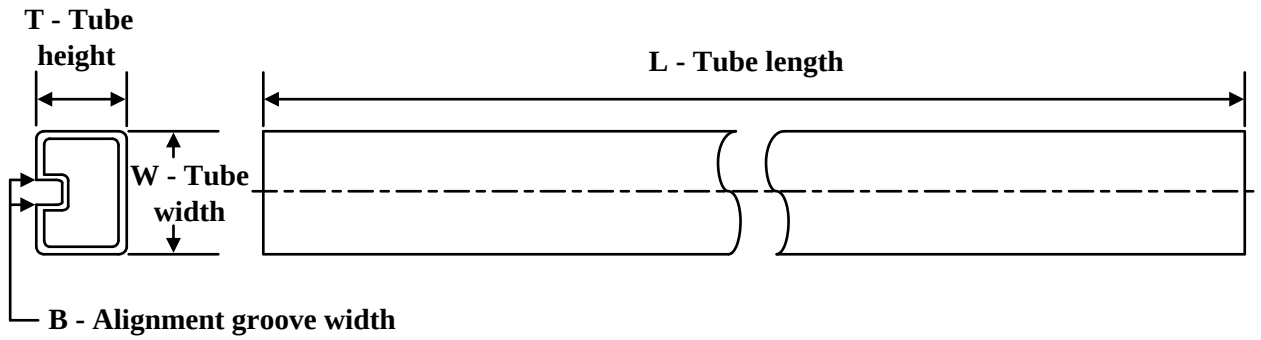
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC555CDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC555CPSR	SO	PS	8	2000	353.0	353.0	32.0
TLC555CPWR	TSSOP	PW	14	2000	353.0	353.0	32.0
TLC555IDR	SOIC	D	8	2500	353.0	353.0	32.0
TLC555QDR	SOIC	D	8	2500	350.0	350.0	43.0
TLC555QDRG4	SOIC	D	8	2500	350.0	350.0	43.0

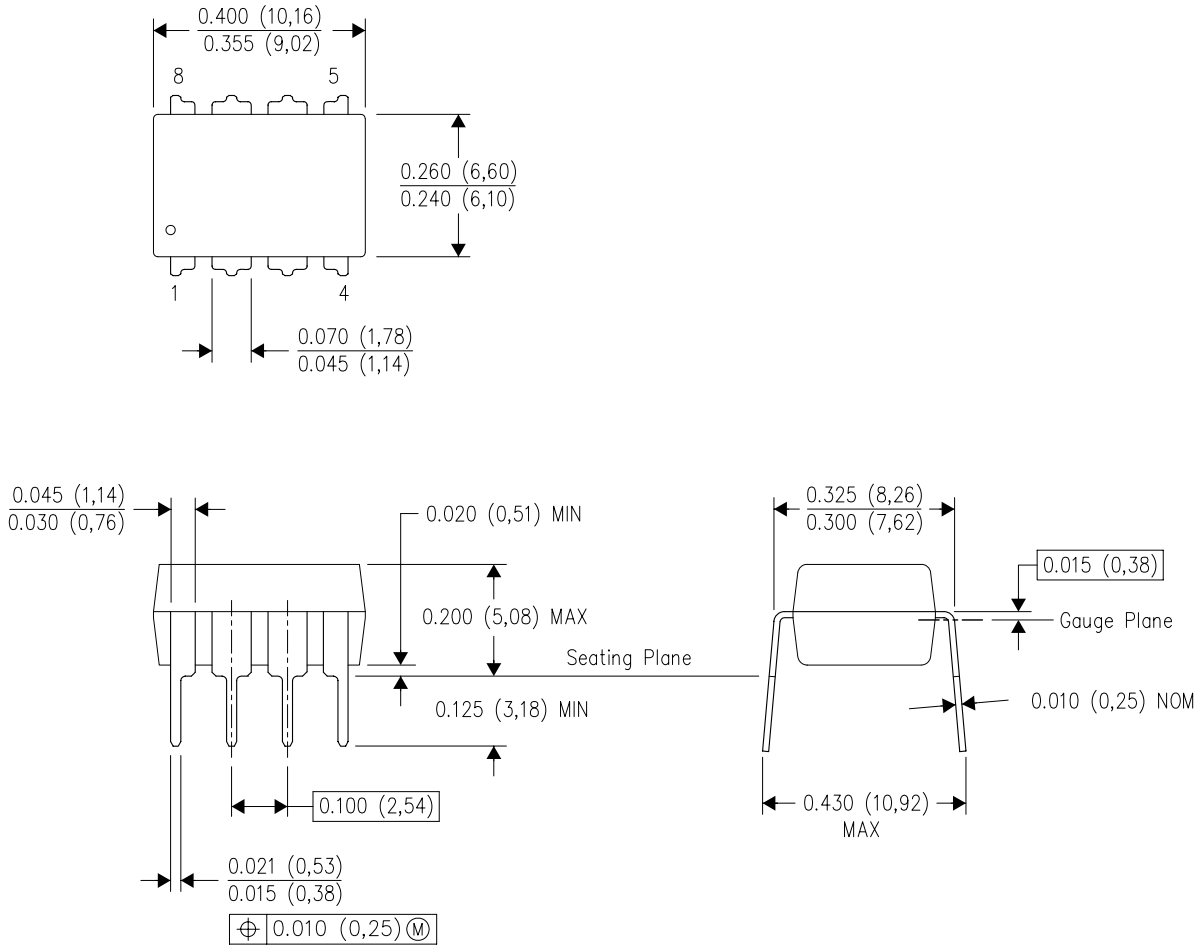
TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-89503012A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLC555CP	P	PDIP	8	50	506	13.97	11230	4.32
TLC555CP	P	PDIP	8	50	506	13.97	11230	4.32
TLC555CP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLC555CP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLC555CPS	PS	SOP	8	80	530	10.5	4000	4.1
TLC555CPS.A	PS	SOP	8	80	530	10.5	4000	4.1
TLC555CPW	PW	TSSOP	14	90	530	10.2	3600	3.5
TLC555CPW.A	PW	TSSOP	14	90	530	10.2	3600	3.5
TLC555IP	P	PDIP	8	50	506	13.97	11230	4.32
TLC555IP	P	PDIP	8	50	506	13.97	11230	4.32
TLC555IP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLC555IP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLC555MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLC555MFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA

P (R–PDIP–T8) PLASTIC DUAL–IN–LINE PACKAGE



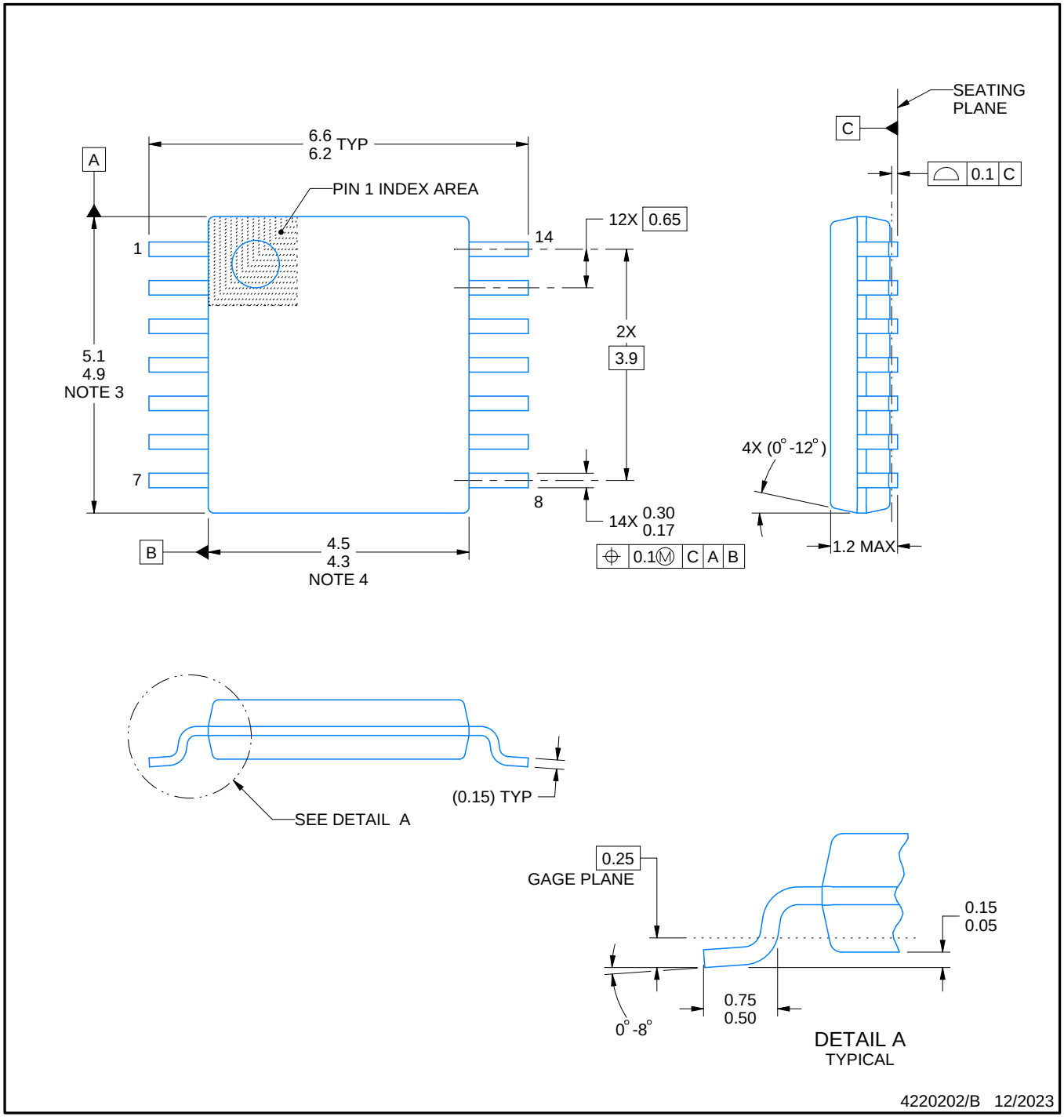
NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001 variation BA.

PACKAGE OUTLINE

PW0014A

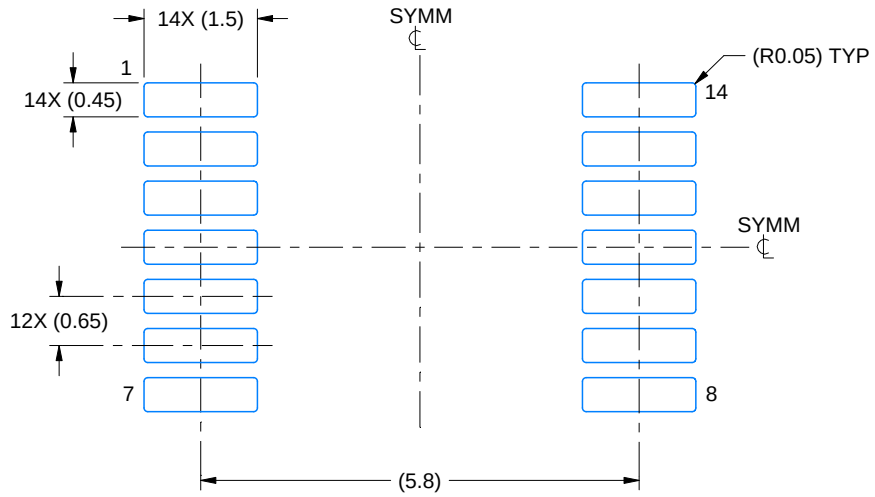
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

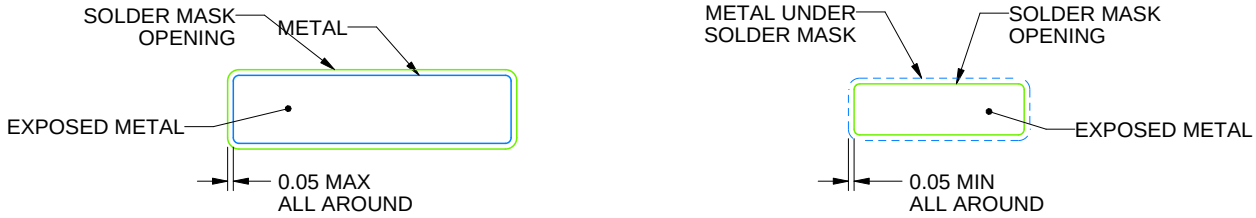


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

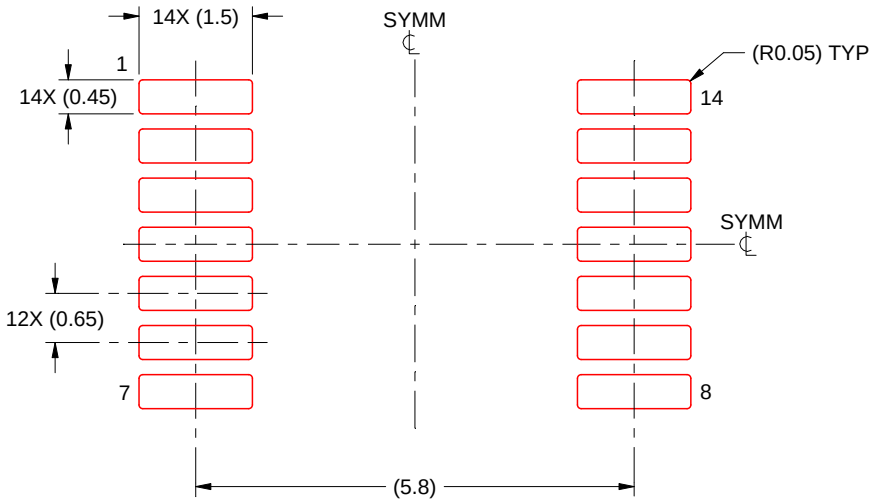


SOLDER MASK DETAILS

4220202/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

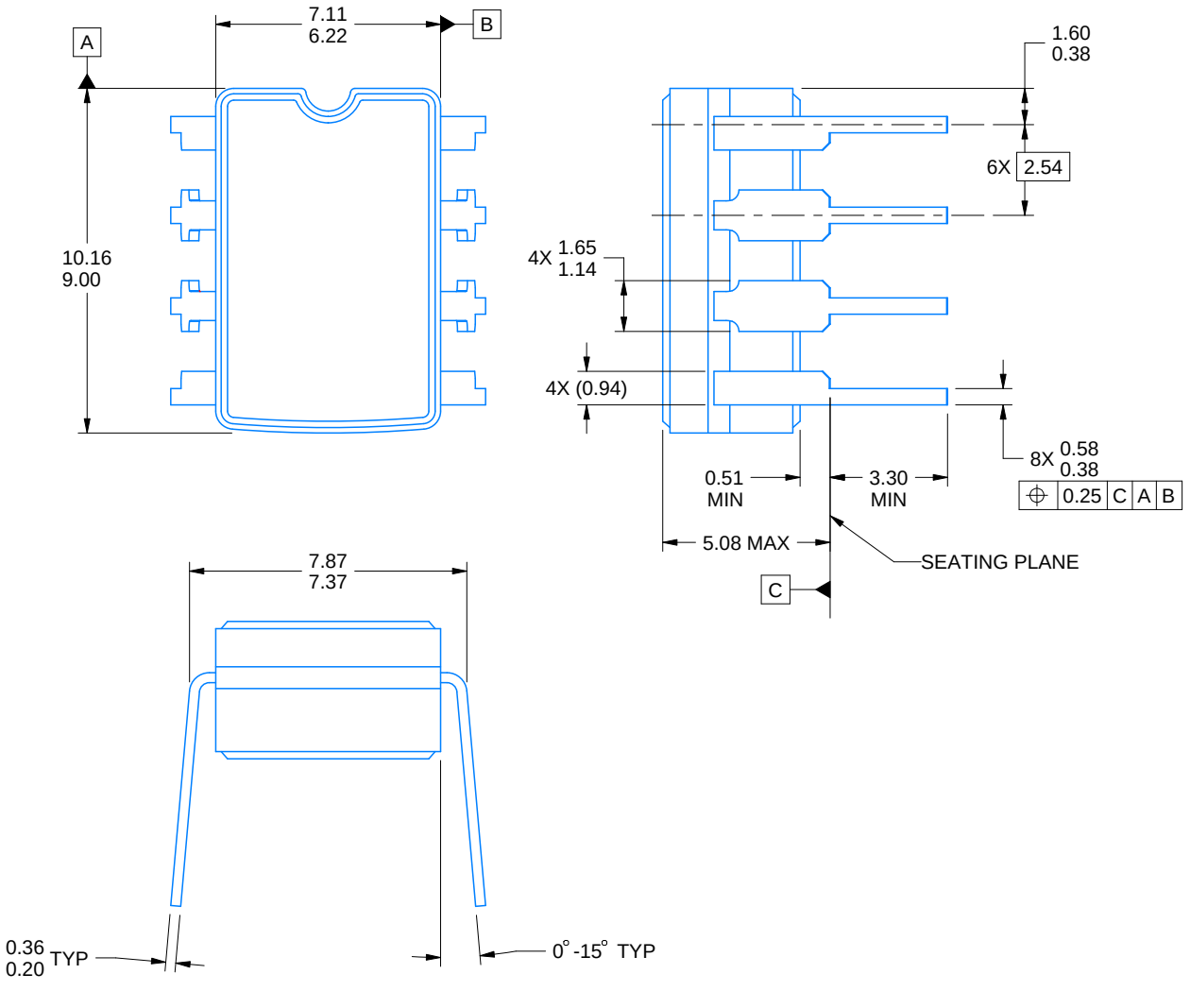
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

PACKAGE OUTLINE

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



4230036/A 09/2023

NOTES:

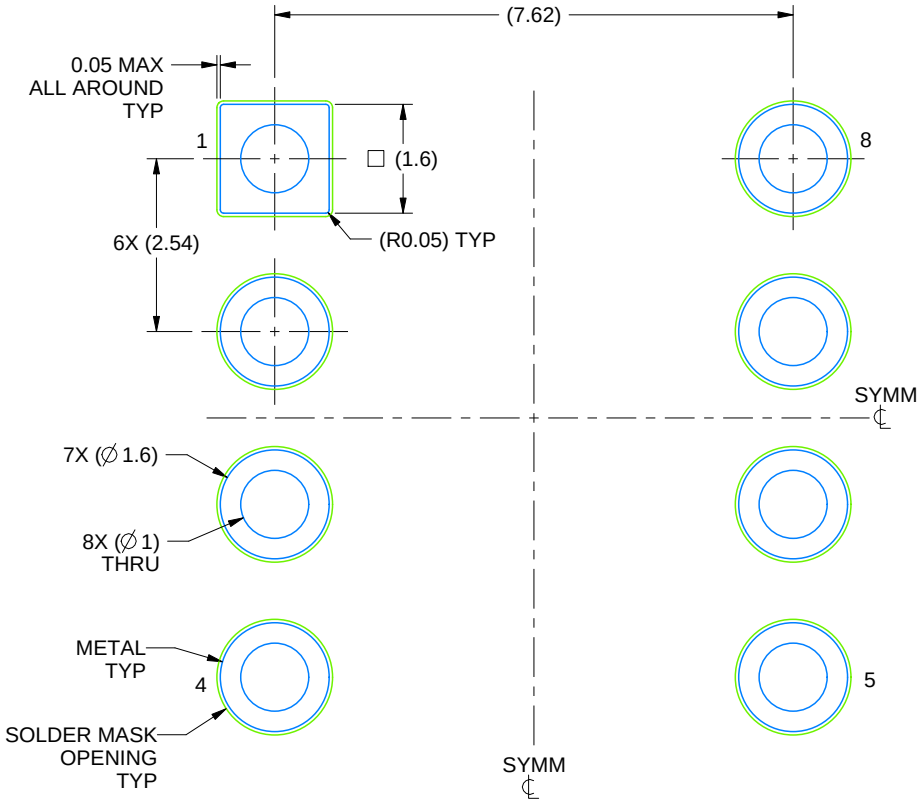
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package can be hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification.
5. Falls within MIL STD 1835 GDIP1-T8

EXAMPLE BOARD LAYOUT

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



LAND PATTERN EXAMPLE
NON SOLDER MASK DEFINED
SCALE: 9X

4230036/A 09/2023

GENERIC PACKAGE VIEW

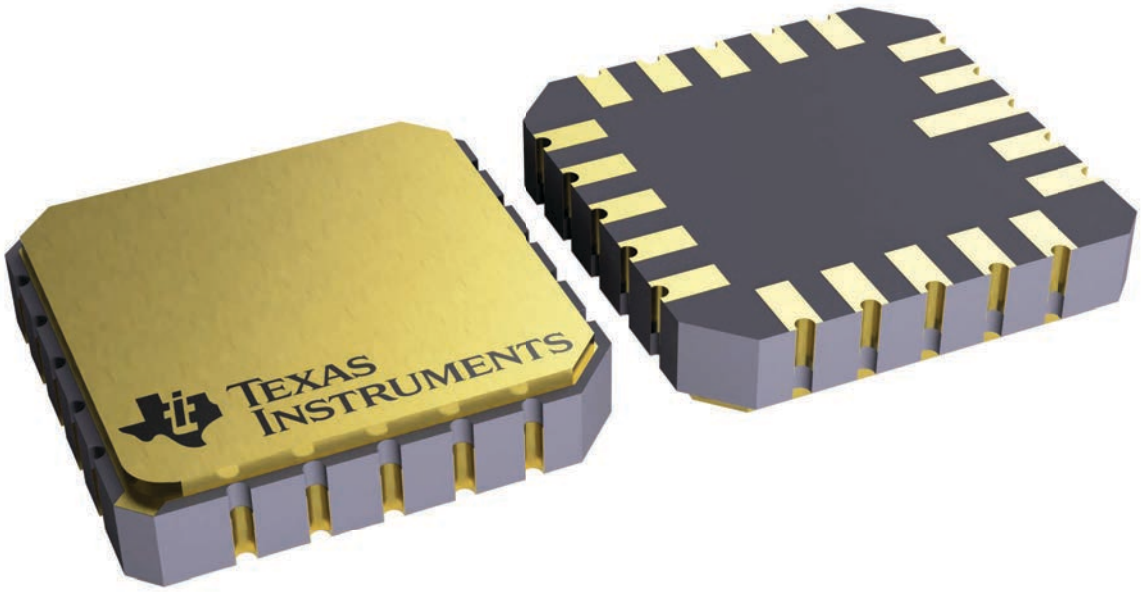
FK 20

LCCC - 2.03 mm max height

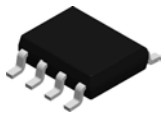
8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4229370VA\

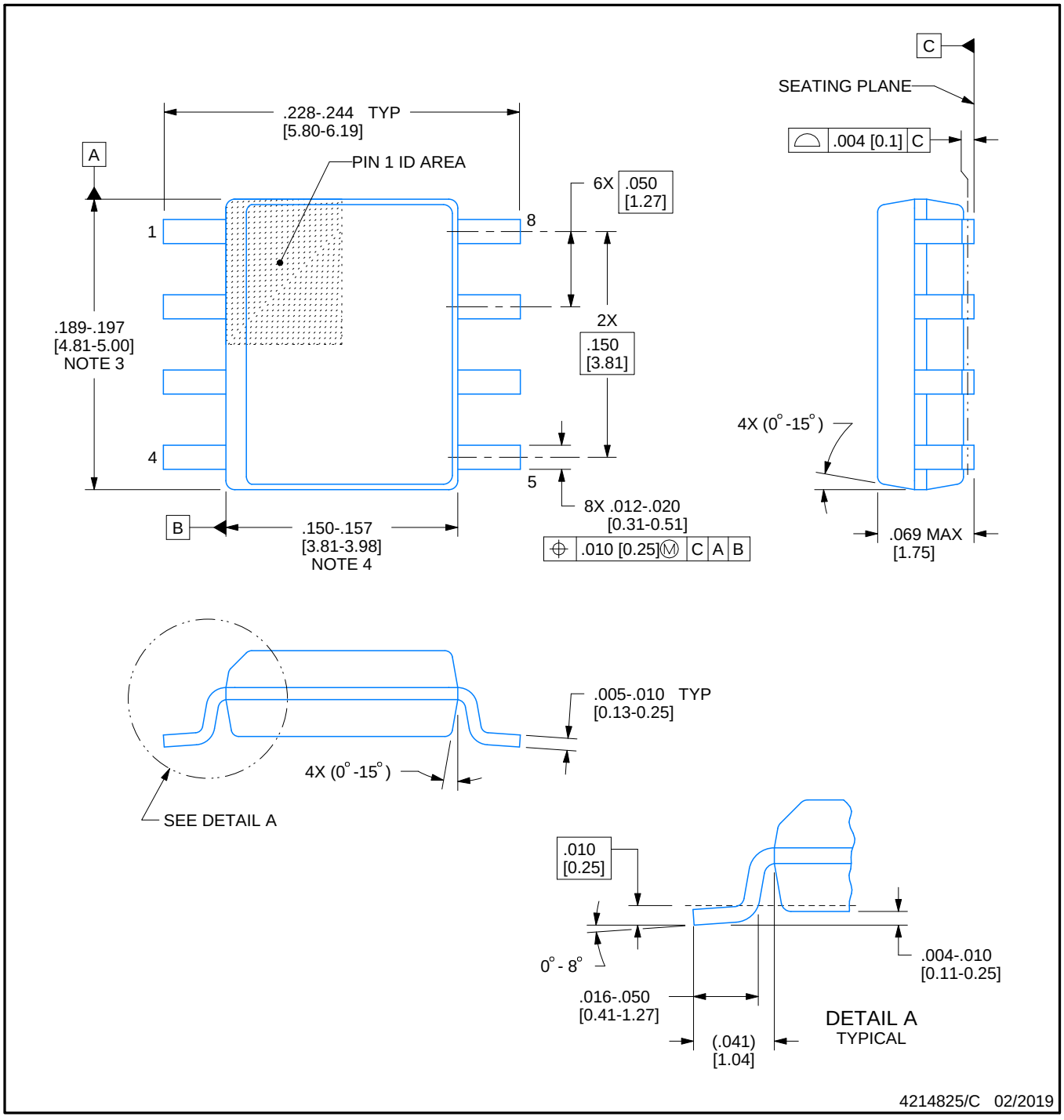


PACKAGE OUTLINE

D0008A

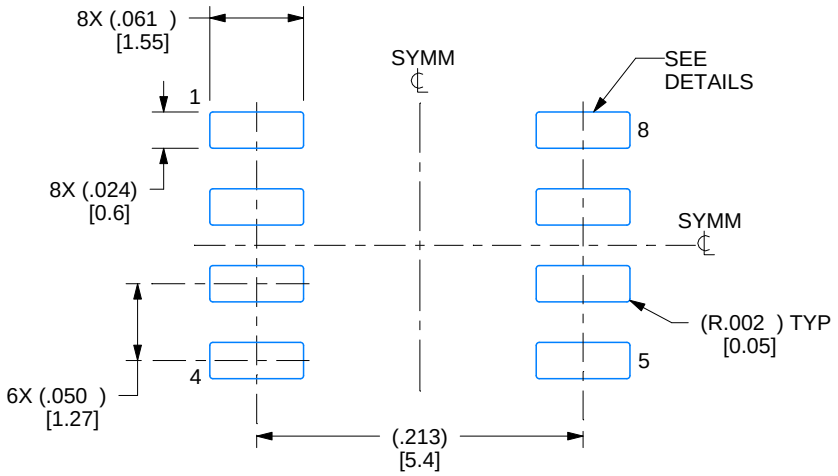
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

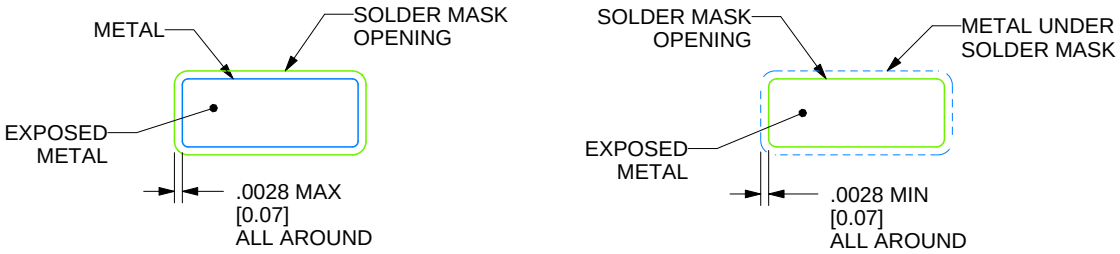


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

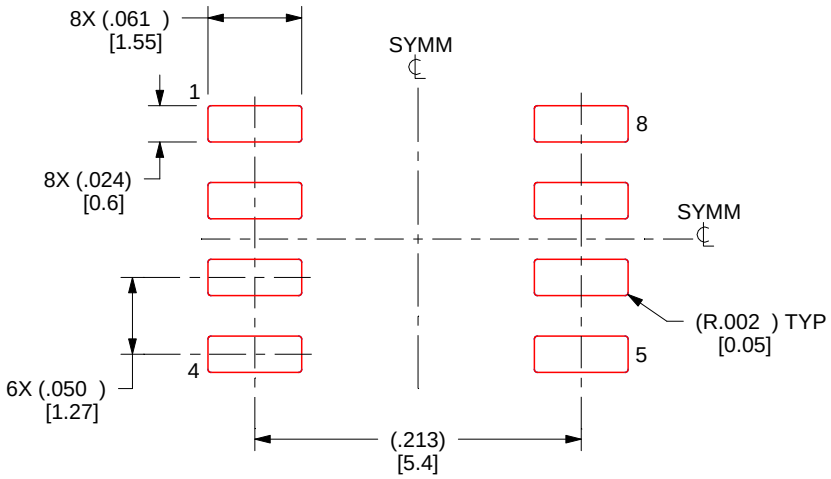
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

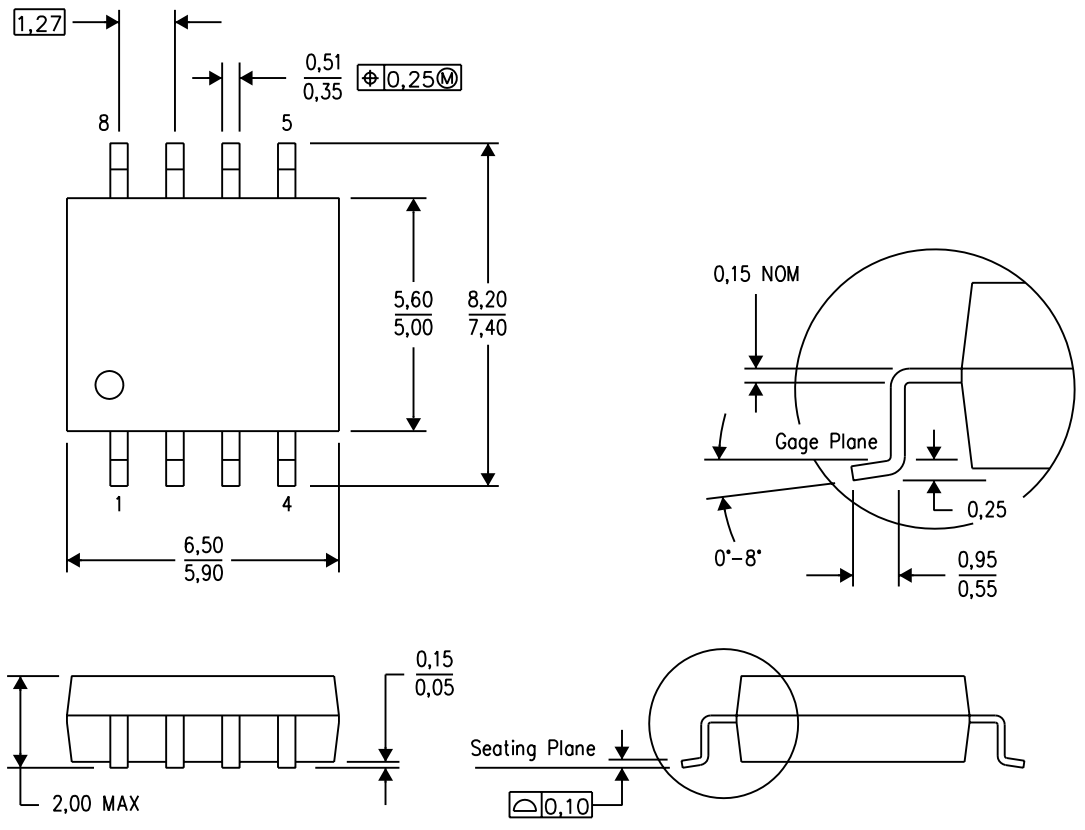
4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

MECHANICAL DATA

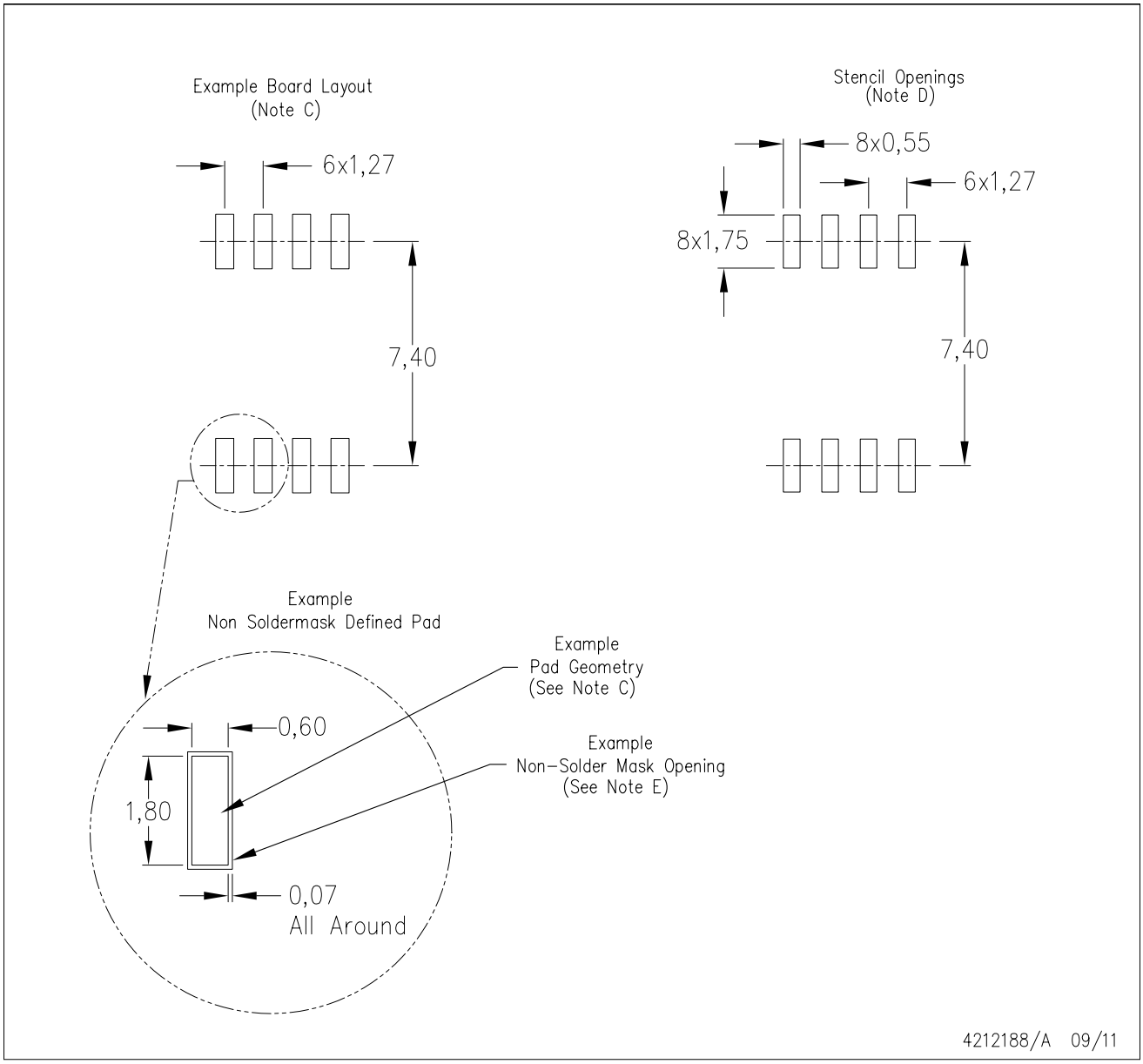
PS (R-PDSO-G8) **PLASTIC SMALL-OUTLINE PACKAGE**



4040063/C 03/03

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

PS (R–PDSO–G8) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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